

8-Bit

SAL-XC866

8-Bit Single-Chip Microcontroller

Data Sheet V1.1 2012-12

Microcontrollers

Edition 2012-12
Published by
Infineon Technologies AG
81726 Munich, Germany
© 2012 Infineon Technologies AG
All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



8-Bit

SAL-XC866

8-Bit Single-Chip Microcontroller

Data Sheet V1.1 2012-12

Microcontrollers



	866 Data Sheet n History: 2012-12	V1.1				
Previous	Version: V1.0 2011-02					
Page	Page Subjects (major changes since last revision)					
-	Removed the "preliminary" wording from the data sheet.					

We Listen to Your Comments

Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to:

mcdocu.comments@infineon.com

Data Sheet V1.1, 2012-12



Table of	Contents	Page
1	Summary of Features	3
2 2.1 2.2 2.3 2.4	General Device Information Block Diagram	6
3 3.1 3.2 3.2.1 3.2.2 3.2.2.1 3.2.2.2 3.2.3 3.2.4 3.3 3.3.1 3.3.2 3.4 3.4.1 3.4.2 3.4.3	Functional Description Processor Architecture Memory Organization Memory Protection Strategy Special Function Register Address Extension by Mapping Address Extension by Paging Bit Protection Scheme SAL-XC866 Register Overview Flash Memory Flash Bank Sectorization Flash Programming Width Interrupt System Interrupt Source Interrupt Priority	. 14 . 15 . 17 . 19 . 21 . 25 . 26 . 38 . 40 . 41 . 42 . 42 . 47 . 49
3.5 3.6 3.7 3.7.1	Parallel Ports	. 53 . 54
3.7.2 3.8 3.8.1 3.8.2	Booting Scheme Clock Generation Unit Recommended External Oscillator Circuits Clock Management	. 56 . 57 . 59 . 61
3.9 3.10 3.11 3.11.1	Power Saving Modes	. 64 . 67
3.11.2 3.12 3.13 3.13.1	Baud Rate Generation using Timer 1	. 71 . 71 . 72
3.14 3.15 3.16	High-Speed Synchronous Serial Interface	. 74 . 76



3.17 3.18 3.18.1 3.18.2 3.19 3.19.1 3.20	Capture/Compare Unit 6 78 Analog-to-Digital Converter 80 ADC Clocking Scheme 81 ADC Conversion Sequence 82 On-Chip Debug Support 83 JTAG ID Register 84 Identification Register 85
4	Electrical Parameters
4.1	General Parameters
4.1.1	Parameter Interpretation
4.1.2	Absolute Maximum Rating
4.1.3	Operating Conditions
4.2	DC Parameters 89
4.2.1	Input/Output Characteristics
4.2.2	Supply Threshold Characteristics
4.2.3	ADC Characteristics 94
4.2.3.1	ADC Conversion Timing 96
4.2.4	Power Supply Current
4.3	AC Parameters 99
4.3.1	Testing Waveforms
4.3.2	Output Rise/Fall Times 100
4.3.3	Power-on Reset and PLL Timing
4.3.4	On-Chip Oscillator Characteristics
4.3.5	JTAG Timing
4.3.6	SSC Master Mode Timing
5	Package and Reliability
5.1	Package Parameters (PG-TSSOP-38)
5.2	Package Outline
5.3	Quality Declaration



8-Bit Single-Chip Microcontroller XC800 Family

SAL-XC866

1 Summary of Features

- High-performance XC800 Core
 - compatible with standard 8051 processor
 - two clocks per machine cycle architecture (for memory access without wait state)
 - two data pointers
- On-chip memory
 - 8 Kbytes of Boot ROM
 - 256 bytes of RAM
 - 512 bytes of XRAM
 - 4/8/16 Kbytes of Flash (includes memory protection strategy)
- I/O port supply at 3.3 V/5.0 V and core logic supply at 2.5 V (generated by embedded voltage regulator)

(further features are on next page)

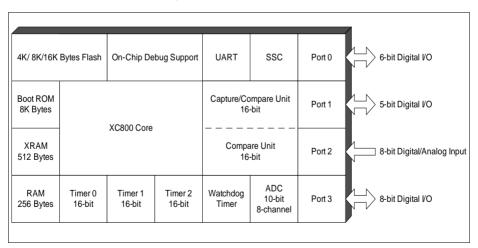


Figure 1 SAL-XC866 Functional Units



Summary of Features

Features (continued):

- · Reset generation
 - Power-On reset
 - Hardware reset
 - Brownout reset for core logic supply
 - Watchdog timer reset
 - Power-Down Wake-up reset
- On-chip OSC and PLL for clock generation
 - PLL loss-of-lock detection
- · Power saving modes
 - slow-down mode
 - idle mode
 - power-down mode with wake-up capability via RXD or EXINT0
 - clock gating control to each peripheral
- Programmable 16-bit Watchdog Timer (WDT)
- Four ports
 - 19 pins as digital I/O
 - 8 pins as digital/analog input
- 8-channel, 10-bit ADC
- Three 16-bit timers
 - Timer 0 and Timer 1 (T0 and T1)
 - Timer 2
- Capture/compare unit for PWM signal generation (CCU6)
- Full-duplex serial interface (UART)
- Synchronous serial channel (SSC)
- On-chip debug support
 - 1 Kbyte of monitor ROM (part of the 8-Kbyte Boot ROM)
 - 64 bytes of monitor RAM
- · PG-TSSOP-38 pin package
- Temperature range T_A:
 - SAL (-40 to 150 °C)



Summary of Features

SAL-XC866 Variant Devices

The SAL-XC866 product family features devices with different configurations and program memory sizes, offering cost-effective solution for different application requirements.

The list of SAL-XC866 devices and their differences are summarized in Table 1.

Table 1 Device Summary

Device Type	Device Name	Power Supply (V)	P-Flash Size (Kbytes)	D-Flash Size (Kbytes)	LIN BSL Support
Flash ¹⁾	SAL-XC866L-4FRA	5.0	12	4	Yes
	SAL-XC866L-2FRA	5.0	4	4	Yes
	SAL-XC866L-4FRA	3.3	12	4	Yes
	SAL-XC866L-2FRA	3.3	4	4	Yes

¹⁾ The flash memory (P-Flash and D-Flash) can be used for code or data.

Ordering Information

The ordering code for Infineon Technologies microcontrollers provides an exact reference to the required product. This ordering code identifies:

- The derivative itself, i.e. its function set, the temperature range, and the supply voltage
- the package and the type of delivery

For the available ordering codes for the SAL-XC866, please refer to your responsible sales representative or your local distributor.

As this document refers to all the derivatives, some descriptions may not apply to a specific product. For simplicity all versions are referred to by the term SAL-XC866 throughout this document.



2 General Device Information

2.1 Block Diagram

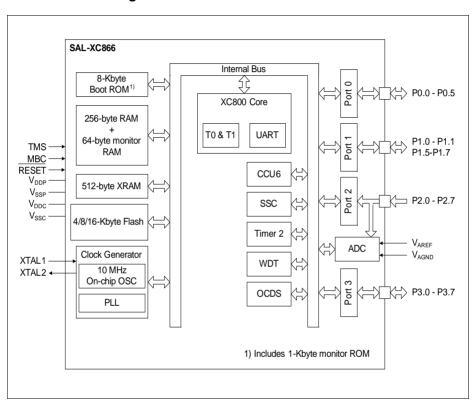


Figure 2 SAL-XC866 Block Diagram



2.2 Logic Symbol

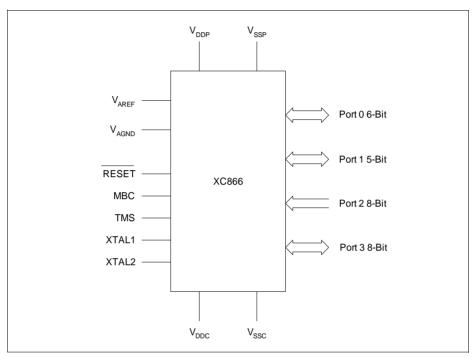


Figure 3 SAL-XC866 Logic Symbol



2.3 Pin Configuration

MBC	1 (38 RESET
P0.3/SCLK_1/COUT63_1	2	37 P3.5/COUT62_0
P0.4/MTSR_1/CC62_1	3	36 P3.4/CC62_0
P0.5/MRST_1/EXINT0_0/COUT62_1	4	35 P3.3/COUT61_0
XTAL2	5	34 P3.2/CCPOS2_2/CC61_0
XTAL1	6	33 P3.1/CCPOS0_2/CC61_2/COUT60_0
V _{ssc}	7	32 P3.0/CCPOS1_2/CC60_0
V _{DDC}	8	31 P3.7/EXINT4/COUT63_0
P1.6/CCPOS1_1/T12HR_0/EXINT6	9	30 P3.6/CTRAP_0
P1.7/CCPOS2_1/T13HR_0	10 XC86	29 P1.5/CCPOS0_1/EXINT5/EXF2_0/RXDO_0
TMS	11	28 P1.1/EXINT3/TDO_1/TXD_0
P0.0/TCK_0/T12HR_1/CC61_1/CLKOUT/RXDO_1	12	27 P1.0/RXD_0/T2EX
P0.2/CTRAP_2/TDO_0/TXD_1	13	26 P2.7/AN7
P0.1/TDI_0/T13HR_1/RXD_1/EXF2_1/COUT61_1	14	25 V _{AREF}
P2.0/CCPOS0_0/EXINT1/T12HR_2/TCK_1/CC61_3/AN0	15	24 V _{AGND}
P2.1/CCPOS1_0/EXINT2/T13HR_2/TDI_1/CC62_3/AN1	16	23 P2.6/AN6
P2.2/CCPOS2_0/CTRAP_1/CC60_3/AN2	17	22 P2.5/AN5
V _{DDP}	18	21 P2.4/AN4
V _{SSP}	19	20 P2.3/AN3

Figure 4 SAL-XC866 Pin Configuration, PG-TSSOP-38 Package (top view)



2.4 Pin Definitions and Functions

Table 2 Pin Definitions and Functions

Symbol	Pin Number	Туре	Reset State	Function	
P0		I/O		port. It can b	-bit bidirectional general purpose I/O be used as alternate functions for the 6, UART, and the SSC.
P0.0	12		Hi-Z	TCK_0 T12HR_1	JTAG Clock Input CCU6 Timer 12 Hardware Run Input
				CC61_1 CLKOUT RXDO_1	Input/Output of Capture/Compare channel 1 Clock Output UART Transmit Data Output
P0.1	14		Hi-Z	TDI_0 T13HR_1	JTAG Serial Data Input CCU6 Timer 13 Hardware Run Input
				RXD_1 COUT61_1	UART Receive Data Input Output of Capture/Compare channel 1
P0.2	13		PU	EXF2_1 CTRAP_2 TDO_0 TXD_1	Timer 2 External Flag Output CCU6 Trap Input JTAG Serial Data Output UART Transmit Data Output/ Clock Output
P0.3	2		Hi-Z	SCK_1 COUT63_1	SSC Clock Input/Output Output of Capture/Compare channel 3
P0.4	3		Hi-Z	MTSR_1 CC62_1	SSC Master Transmit Output/ Slave Receive Input Input/Output of Capture/Compare channel 2
P0.5	4		Hi-Z	MRST_1 EXINT0_0 COUT62_1	SSC Master Receive Input/ Slave Transmit Output External Interrupt Input 0 Output of Capture/Compare channel 2



Table 2 Pin Definitions and Functions (cont'd)

Symbol	Pin Number	Туре	Reset State	Function	
P1		I/O		Port 1 Port 1 is a 5-bit bidirectional general purpose I/O port. It can be used as alternate functions for the JTAG, CCU6, UART, and the SSC.	
P1.0	27		PU	RXD_0 T2EX	UART Receive Data Input Timer 2 External Trigger Input
P1.1	28		PU	EXINT3 TDO_1 TXD_0	External Interrupt Input 3 JTAG Serial Data Output UART Transmit Data Output/ Clock Output
P1.5	29		PU	CCPOS0_1 EXINT5 EXF2_0 RXDO_0	CCU6 Hall Input 0 External Interrupt Input 5 TImer 2 External Flag Output UART Transmit Data Output
P1.6	9		PU	CCPOS1_1 T12HR_0 EXINT6	CCU6 Hall Input 1 CCU6 Timer 12 Hardware Run Input External Interrupt Input 6
P1.7	10		PU	CCPOS2_1 T13HR_0	
					.6 can be used as a software chip t for the SSC.



Table 2 Pin Definitions and Functions (cont'd)

Symbol	Pin Number	Туре	Reset State	Function	
P2		I		Port 2 Port 2 is an 8-bit general purpose input-only port. It can be used as alternate functions for the digital inputs of the JTAG and CCU6. It is also used as the analog inputs for the ADC.	
P2.0	15		Hi-Z	CCPOS0_0 EXINT1 T12HR_2	CCU6 Hall Input 0 External Interrupt Input 1 CCU6 Timer 12 Hardware Run Input
				TCK_1 CC61_3 AN0	JTAG Clock Input Input of Capture/Compare channel 1 Analog Input 0
P2.1	16		Hi-Z	CCPOS1_0 EXINT2 T13HR_2	CCU6 Hall Input 1 External Interrupt Input 2 CCU6 Timer 13 Hardware Run Input
				TDI_1 CC62_3 AN1	JTAG Serial Data Input Input of Capture/Compare channel 2 Analog Input 1
P2.2	17		Hi-Z	CCPOS2_0 CTRAP_1 CC60_3 AN2	CCU6 Hall Input 2 CCU6 Trap Input Input of Capture/Compare channel 0 Analog Input 2
P2.3	20		Hi-Z	AN3	Analog Input 3
P2.4	21		Hi-Z	AN4	Analog Input 4
P2.5	22		Hi-Z	AN5	Analog Input 5
P2.6	23		Hi-Z	AN6	Analog Input 6
P2.7	26		Hi-Z	AN7	Analog Input 7



Table 2 Pin Definitions and Functions (cont'd)

Symbol	Pin Number	Туре	Reset State	Function	
P3		I			directional general purpose I/O port. It as alternate functions for the CCU6.
P3.0	32		Hi-Z	CCPOS1_2 CC60_0	CCU6 Hall Input 1 Input/Output of Capture/Compare channel 0
P3.1	33		Hi-Z	CCPOS0_2 CC61_2	CCU6 Hall Input 0 Input/Output of Capture/Compare channel 1
				COUT60_0	Output of Capture/Compare channel 0
P3.2	34		Hi-Z	CCPOS2_2 CC61_0	CCU6 Hall Input 2 Input/Output of Capture/Compare channel 1
P3.3	35		Hi-Z	COUT61_0	Output of Capture/Compare channel 1
P3.4	36		Hi-Z	CC62_0	Input/Output of Capture/Compare channel 2
P3.5	37		Hi-Z	COUT62_0	Output of Capture/Compare channel 2
P3.6	30		PD	CTRAP_0	CCU6 Trap Input
P3.7	31		Hi-Z	EXINT4 COUT63_0	External Interrupt Input 4 Output of Capture/Compare channel 3



Table 2 Pin Definitions and Functions (cont'd)

Symbol	Pin Number	Туре	Reset State	Function
V_{DDP}	18	-	_	I/O Port Supply (3.3 V/5.0 V) Also used by EVR and analog modules.
V _{SSP}	19	_	_	I/O Port Ground
V _{DDC}	8	_	_	Core Supply Monitor (2.5 V)
V _{SSC}	7	_	_	Core Supply Ground
V _{AREF}	25	_	_	ADC Reference Voltage
V _{AGND}	24	_	_	ADC Reference Ground
XTAL1	6	I	Hi-Z	External Oscillator Input (NC if not needed)
XTAL2	5	0	Hi-Z	External Oscillator Output (NC if not needed)
TMS	11	I	PD	Test Mode Select
RESET	38	I	PU	Reset Input
MBC ¹⁾	1	I	PU	Monitor & BootStrap Loader Control

An external pull-up device in the range of 4.7 k Ω to 100 k Ω is required to enter user mode. Alternatively MBC can be tied to high if alternate functions (for debugging) of the pin are not utilized.



3 Functional Description

3.1 Processor Architecture

The SAL-XC866 is based on a high-performance 8-bit Central Processing Unit (CPU) that is compatible with the standard 8051 processor. While the standard 8051 processor is designed around a 12-clock machine cycle, the SAL-XC866 CPU uses a 2-clock machine cycle. This allows fast access to ROM or RAM memories without wait state. Access to the Flash memory, however, requires an additional wait state (one machine cycle). The instruction set consists of 45% one-byte, 41% two-byte and 14% three-byte instructions.

The SAL-XC866 CPU provides a range of debugging features, including basic stop/start, single-step execution, breakpoint support and read/write access to the data memory, program memory and SFRs. **Figure 5** shows the CPU functional blocks.

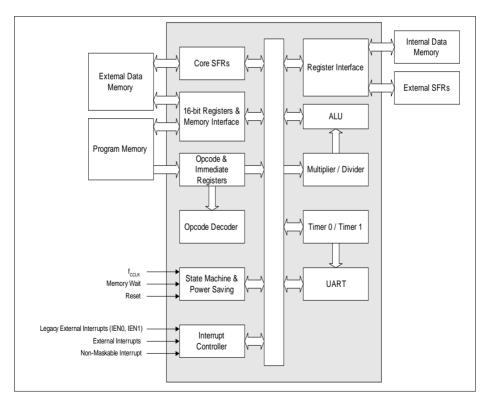


Figure 5 CPU Block Diagram



3.2 Memory Organization

The SAL-XC866 CPU operates in the following five address spaces:

- 8 Kbytes of Boot ROM program memory
- 256 bytes of internal RAM data memory
- 512 bytes of XRAM memory
- a 128-byte Special Function Register area
- 4/8/16 Kbytes of Flash program memory



Figure 6 illustrates the memory address spaces of the SAL-XC866-4FR devices.

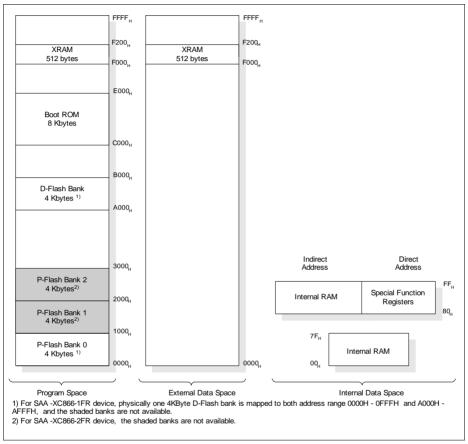


Figure 6 Memory Map of SAL-XC866 Flash Devices



3.2.1 Memory Protection Strategy

The SAL-XC866 memory protection strategy includes:

- Read-out protection: The Flash Memory can be enabled for read-out protection and ROM memory is always protected.
- Program and erase protection: The Flash memory in all devices can be enabled for program and erase protection.

Flash memory protection is available in two modes:

- Mode 0: Only the P-Flash is protected; the D-Flash is unprotected
- Mode 1: Both the P-Flash and D-Flash are protected

The selection of each protection mode and the restrictions imposed are summarized in **Table 3**.

Table 3 Flash Protection Modes

Mode	0	1				
Activation Program a valid password via BSL mode 6						
Selection	MSB of password = 0	MSB of password = 1				
P-Flash contents can be read by	Read instructions in the P-Flash or D-Flash					
P-Flash program and erase	Not possible	Not possible				
D-Flash contents can be read by	Read instructions in any program memory	Read instructions in the P-Flash or D-Flash				
D-Flash program	Possible	Not possible				
D-Flash erase	Possible, on the condition that bit DFLASHEN in register MISC_CON is set to 1 prior to each erase operation	Not possible				

BSL mode 6, which is used for enabling Flash protection, can also be used for disabling Flash protection. Here, the programmed password must be provided by the user. A password match triggers an automatic erase of the read-protected Flash contents, see **Table 4**, and the programmed password is erased. The Flash protection is then disabled upon the next reset.

For XC866-2FR and XC866-4FR devices:

The selection of protection type is summarized in **Table 4**.



Table 4 Flash Protection Type for XC866-2FR and XC866-4FR devices

PASSWORD	Type of Protection	Flash Banks to Erase when Unprotected
1XXXXXXX _B	Flash Protection Mode 1	All Banks
0XXXXXXX _B	Flash Protection Mode 0	P-Flash Bank

Although no protection scheme can be considered infallible, the SAL-XC866 memory protection strategy provides a very high level of protection for a general purpose microcontroller.



Reset Value: 00...

3.2.2 Special Function Register

The Special Function Registers (SFRs) occupy direct internal data memory space in the range $80_{\rm H}$ to FF_H. All registers, except the program counter, reside in the SFR area. The SFRs include pointers and registers that provide an interface between the CPU and the on-chip peripherals. As the 128-SFR range is less than the total number of registers required, address extension mechanisms are required to increase the number of addressable SFRs. The address extension mechanisms include:

- Mapping
- Paging

3.2.2.1 Address Extension by Mapping

Address extension is performed at the system level by mapping. The SFR area is extended into two portions: the standard (non-mapped) SFR area and the mapped SFR area. Each portion supports the same address range $80_{\rm H}$ to FF_H, bringing the number of addressable SFRs to 256. The extended address range is not directly controlled by the CPU instruction itself, but is derived from bit RMAP in the system control register SYSCON0 at address $8F_{\rm H}$. To access SFRs in the mapped area, bit RMAP in SFR SYSCON0 must be set. Alternatively, the SFRs in the standard area can be accessed by clearing bit RMAP. The SFR area can be selected as shown in Figure 7.

SYSCON0 System Control Register 0

_	,		,					
	7	6	5	4	3	2	1	0
			0	1	1	1	0	RMAP
-		•	r	•	•	rw	r	rw

Field	Bits	Туре	Description
RMAP	0	rw	Special Function Register Map Control The access to the standard SFR area is enabled. The access to the mapped SFR area is enabled.
1	2	rw	Reserved Returns the last value if read; should be written with 1.
0	1,[7:3]	r	Reserved Returns 0 if read; should be written with 0.



Note: The RMAP bit must be cleared/set by ANL or ORL instructions. The rest bits of SYSCON0 should not be modified.

As long as bit RMAP is set, the mapped SFR area can be accessed. This bit is not cleared automatically by hardware. Thus, before standard/mapped registers are accessed, bit RMAP must be cleared/set, respectively, by software.

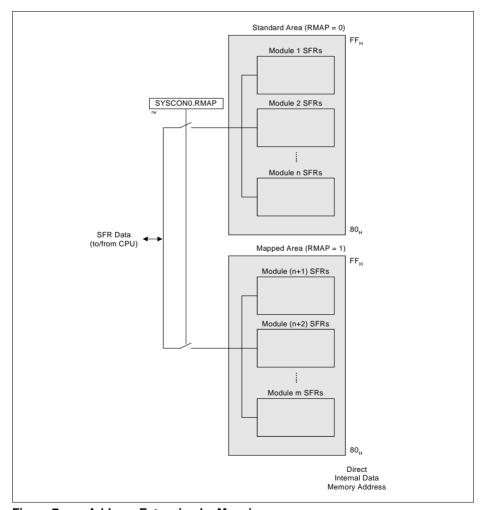


Figure 7 Address Extension by Mapping



3.2.2.2 Address Extension by Paging

Address extension is further performed at the module level by paging. With the address extension by mapping, the SAL-XC866 has a 256-SFR address range. However, this is still less than the total number of SFRs needed by the on-chip peripherals. To meet this requirement, some peripherals have a built-in local address extension mechanism for increasing the number of addressable SFRs. The extended address range is not directly controlled by the CPU instruction itself, but is derived from bit field PAGE in the module page register MOD_PAGE. Hence, the bit field PAGE must be programmed before accessing the SFR of the target module. Each module may contain a different number of pages and a different number of SFRs per page, depending on the specific requirement. Besides setting the correct RMAP bit value to select the SFR area, the user must also ensure that a valid PAGE is selected to target the desired SFR. A page inside the extended address range can be selected as shown in Figure 8.

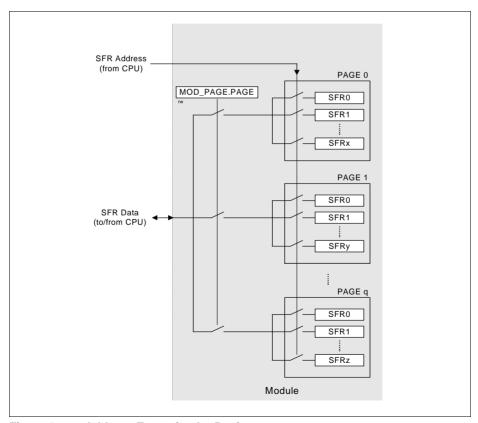


Figure 8 Address Extension by Paging



In order to access a register located in a page different from the actual one, the current page must be left. This is done by reprogramming the bit field PAGE in the page register. Only then can the desired access be performed.

If an interrupt routine is initiated between the page register access and the module register access, and the interrupt needs to access a register located in another page, the current page setting can be saved, the new one programmed and finally, the old page setting restored. This is possible with the storage fields MOD_STx (x = 0 - 3) for the save and restore action of the current page setting. By indicating which storage bit field should be used in parallel with the new page value, a single write operation can:

- Save the contents of PAGE in MOD_STx before overwriting with the new value (this is done in the beginning of the interrupt routine to save the current page setting and program the new page number); or
- Overwrite the contents of PAGE with the contents of MOD_STx, ignoring the value written to the bit positions of PAGE (this is done at the end of the interrupt routine to restore the previous page setting before the interrupt occurred)

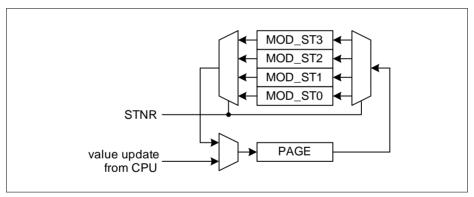


Figure 9 Storage Elements for Paging

With this mechanism, a certain number of interrupt routines (or other routines) can perform page changes without reading and storing the previously used page information. The use of only write operations makes the system simpler and faster. Consequently, this mechanism significantly improves the performance of short interrupt routines.

The SAL-XC866 supports local address extension for:

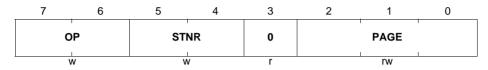
- Parallel Ports
- Analog-to-Digital Converter (ADC)
- Capture/Compare Unit 6 (CCU6)
- System Control Registers



The page register has the following definition:

MOD_PAGE Page Register for module MOD

Reset Value: 00_H



Field	Bits	Туре	Description
PAGE	[2:0]	rw	Page Bits When written, the value indicates the new page. When read, the value indicates the currently active page.
STNR	[5:4]	w	Storage Number This number indicates which storage bit field is the target of the operation defined by bit field OP. If OP = 10 _B , the contents of PAGE are saved in MOD_STx before being overwritten with the new value. If OP = 11 _B , the contents of PAGE are overwritten by the contents of MOD_STx. The value written to the bit positions of PAGE is ignored. 00 MOD_ST0 is selected. 01 MOD_ST1 is selected. 10 MOD_ST2 is selected. 11 MOD_ST3 is selected.



Field	Bits	Туре	Description
OP	[7:6]	w	Operation OX Manual page mode. The value of STNR is ignored and PAGE is directly written. 10 New page programming with automatic page saving. The value written to the bit positions of PAGE is stored. In parallel, the previous contents of PAGE are saved in the storage bit field MOD_STx indicated by STNR. 11 Automatic restore page action. The value written to the bit positions PAGE is ignored and instead, PAGE is overwritten by the contents of the storage bit field MOD_STx indicated by STNR.
0	3	r	Reserved Returns 0 if read; should be written with 0.



Reset Value: 07 L

3.2.3 Bit Protection Scheme

The bit protection scheme prevents direct software writing of selected bits (i.e., protected bits) using the PASSWD register. When the bit field MODE is $11_{\rm B}$, writing $10011_{\rm B}$ to the bit field PASS opens access to writing of all protected bits, and writing $10101_{\rm B}$ to the bit field PASS closes access to writing of all protected bits. Note that access is opened for maximum 32 CCLKs if the "close access" password is not written. If "open access" password is written again before the end of 32 CCLK cycles, there will be a recount of 32 CCLK cycles. The protected bits include NDIV, WDTEN, PD, and SD.

PASSWD Password Register

	J						•••
7	6	5	4	3	2	1	0
	1	PASS		1	PROTECT _S	МС	DDE
		wh			rh	r	W

Field	Bits	Туре	Description
MODE	[1:0]	rw	Bit Protection Scheme Control bits 00 Scheme Disabled 11 Scheme Enabled (default) Others: Scheme Enabled These two bits cannot be written directly. To change the value between 11 _B and 00 _B , the bit field PASS must be written with 11000 _B ; only then, will the MODE[1:0] be registered.
PROTECT_S	2	rh	Bit Protection Signal Status bit This bit shows the status of the protection. O Software is able to write to all protected bits. Software is unable to write to any protected bits.
PASS	[7:3]	wh	Password bits The Bit Protection Scheme only recognizes three patterns. 11000 _B Enables writing of the bit field MODE. 10011 _B Opens access to writing of all protected bits. 10101 _B Closes access to writing of all protected bits.



3.2.4 SAL-XC866 Register Overview

The SFRs of the SAL-XC866 are organized into groups according to their functional units. The contents (bits) of the SFRs are summarized in **Table 5** to **Table 13**, with the addresses of the bitaddressable SFRs appearing in bold typeface.

The CPU SFRs can be accessed in both the standard and mapped memory areas (RMAP = 0 or 1).

Table 5 CPU Register Overview

Addr	Register Name		Bit	7	6	5	4	3	2	1	0
RMAP =	0 or 1			I				I	I		I
81 _H	SP	Reset: 07 _H	Bit Field				S	Р			
	Stack Pointer Register		Туре				r	w			
82 _H	DPL	Reset: 00 _H	Bit Field	DPL7	DPL6	DPL5	DPL4	DPL3	DPL2	DPL1	DPL0
	Data Pointer Register Lo	w	Туре	rw	rw	rw	rw	rw	rw	rw	rw
83 _H	DPH	Reset: 00 _H	Bit Field	DPH7	DPH6	DPH5	DPH4	DPH3	DPH2	DPH1	DPH0
	Data Pointer Register Hi	gh	Туре	rw	rw	rw	rw	rw	rw	rw	rw
87 _H	PCON	Reset: 00 _H	Bit Field	SMOD		0		GF1	GF0	0	IDLE
	Power Control Register		Туре	rw		r		rw	rw	r	rw
88 _H	TCON	Reset: 00 _H	Bit Field	TF1	TR1	TF0	TR0	IE1	IT1	IE0	IT0
	Timer Control Register		Туре	rwh	rw	rwh	rw	rwh	rw	rwh	rw
89 _H	TMOD	Reset: 00 _H	Bit Field	GATE1	0	T.	1 M	GATE0	0	TO	M
	Timer Mode Register		Туре	rw	r	r	w	rw	r	r	w
8A _H	TL0	Reset: 00 _H	Bit Field				V	٩L			
	Timer 0 Register Low		Туре				rv	vh			
8B _H	TL1	Reset: 00 _H	Bit Field				V	٩L			
	Timer 1 Register Low		Туре				rv	vh			
8C _H	TH0	Reset: 00 _H	Bit Field				V	٩L			
	Timer 0 Register High		Туре				rv	vh			
8D _H	TH1	Reset: 00 _H	Bit Field				V	٩L			
	Timer 1 Register High		Туре				rv	vh			
98 _H	SCON	Reset: 00 _H	Bit Field	SM0	SM1	SM2	REN	TB8	RB8	TI	RI
	Serial Channel Control R	egister	Type	rw	rw	rw	rw	rw	rwh	rwh	rwh
99 _H	SBUF	Reset: 00 _H	Bit Field				V	٩L			
	Serial Data Buffer Regist	er	Type				rv	vh			
A2 _H	EO	Reset: 00 _H	Bit Field		0		TRAP_	0			DPSEL
	Extended Operation Reg	ister					EN				0
			Туре		r		rw		r		rw
A8 _H	IEN0 Interrupt Enable Register	Reset: 00 _H	Bit Field	EA	0	ET2	ES	ET1	EX1	ET0	EX0
	, ,		Туре	rw	r	rw	rw	rw	rw	rw	rw
B8 _H	IP Interrupt Priority Register	Reset: 00 _H	Bit Field)	PT2	PS	PT1	PX1	PT0	PX0
	, , ,		Туре		<u> </u>	rw	rw	rw	rw	rw	rw
B9 _H	IPH Interrupt Priority Register	Reset: 00 _H	Bit Field)	PT2H	PSH	PT1H	PX1H	PT0H	PX0H
_	1 1		Туре		r	rw	rw	rw	rw	rw	rw
D0 _H	PSW Program Status Word Re	Reset: 00 _H	Bit Field	CY	AC	F0	RS1	RS0	OV	F1	Р
			Туре	rw	rwh	rwh	rw	rw	rwh	rwh	rh
E0 _H	ACC	Reset: 00 _H	Bit Field	ACC7	ACC6	ACC5	ACC4	ACC3	ACC2	ACC1	ACC0
	Accumulator Register	Туре	rw	rw	rw	rw	rw	rw	rw	rw	
E8 _H	IEN1 Interrupt Enable Registe	Reset: 00 _H	Bit Field	ECCIP 3	ECCIP 2	ECCIP 1	ECCIP 0	EXM	EX2	ESSC	EADC
			Туре	rw	rw	rw	rw	rw	rw	rw	rw



Table 5 CPU Register Overview (cont'd)

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
F0 _H	B Reset: 00 _H	Bit Field	B7	B6	B5	B4	B3	B2	B1	B0
	B Register	Туре	rw	rw	rw	rw	rw	rw	rw	rw
F8 _H	IP1 Reset: 00 _H Interrupt Priority Register 1	Bit Field	PCCIP 3	PCCIP 2	PCCIP 1	PCCIP 0	PXM	PX2	PSSC	PADC
		Туре	rw	rw	rw	rw	rw	rw	rw	rw
F9 _H	IPH1 Reset: 00 _H Interrupt Priority Register 1 High	Bit Field	PCCIP 3H	PCCIP 2H	PCCIP 1H	PCCIP 0H	PXMH	PX2H	PSSCH	PADC H
		Туре	rw	rw	rw	rw	rw	rw	rw	rw

The system control SFRs can be accessed in the standard memory area (RMAP = 0).

Table 6 System Control Register Overview

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
RMAP =	0 or 1		1			I	I			
8F _H	SYSCON0 Reset: 00 _H	Bit Field				0				RMAP
	System Control Register 0	Туре				r				rw
RMAP =	0	•								
BF _H	SCU_PAGE Reset: 00 _H	Bit Field	C)P	ST	NR	0		PAGE	
	Page Register for System Control	Туре	,	w	١	W	r	r		
RMAP =	0, Page 0									
B3 _H	MODPISEL Reset: 00 _H Peripheral Input Select Register	Bit Field		0	JTAG TDIS	JTAG TCKS		0	EXINT 0IS	URRIS
		Type		r	rw	rw		r	rw	rw
B4 _H	IRCON0 Reset: 00 _H Interrupt Request Register 0	Bit Field	0	EXINT 6	EXINT 5	EXINT 4	EXINT 3	EXINT 2	EXINT 1	EXINT 0
		Туре	r	rwh	rwh	rwh	rwh	rwh	rwh	rwh
B5 _H	IRCON1 Reset: 00 _H Interrupt Request Register 1	Bit Field		0		ADCS RC1	ADCS RC0	RIR	TIR	EIR
		Туре		r		rwh	rwh	rwh	rwh	rwh
B7 _H	EXICON0 Reset: 00 _H	Bit Field	EXI	NT3	EXI	NT2	EXI	NT1	EXI	NT0
	External Interrupt Control Register 0	Туре	r	w	r	w	r	w	rw	
BA _H	EXICON1 Reset: 00 _H	Bit Field	0 EXI		NT6	EXI	NT5	EXI	NT4	
	External Interrupt Control Register 1	Туре		r	r	w	r	w	r	w
BB _H	NMICON Reset: 00 _H NMI Control Register	Bit Field	0	NMI ECC	NMI VDDP	NMI VDD	NMI OCDS	NMI FLASH	NMI PLL	NMI WDT
		Туре	r	rw	rw	rw	rw	rw	rw	rw
BC _H	NMISR Reset: 00 _H NMI Status Register	Bit Field	0	FNMI ECC	FNMI VDDP	FNMI VDD	FNMI OCDS	FNMI FLASH	FNMI PLL	FNMI WDT
		Type	r	rwh	rwh	rwh	rwh	rwh	rwh	rwh
BD _H	BCON Reset: 00 _H	Bit Field	BG	SEL	0	BREN		BRPRE		R
	Baud Rate Control Register	Type	r	w	r	rw		rw		rw
BE _H	BG Reset: 00 _H	Bit Field				BR_V	ALUE			
	Baud Rate Timer/Reload Register	Туре					w			
E9 _H	FDCON Reset: 00 _H Fractional Divider Control Register	Bit Field	BGS	SYNEN	ERRSY N	EOFSY N	BRK	NDOV	FDM	FDEN
		Type	rw	rw	rwh	rwh	rwh	rwh	rw	rw
EA _H	FDSTEP Reset: 00 _H	Bit Field				ST	EP			
	Fractional Divider Reload Register	Туре					w			
EB _H	FDRES Reset: 00 _H	Bit Field				RES	ULT			
	Fractional Divider Result Register	Туре				r	h			
RMAP =	0, Page 1	-	-	-		-		-		



Table 6 System Control Register Overview (cont'd)

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
B3 _H	ID Reset: 01 _H	Bit Field			PRODIC				VERID	
	Identity Register	Туре			r				r	
B4 _H	PMCON0 Reset: 00 _H Power Mode Control Register 0	Bit Field	0	WDT RST	WKRS	WK SEL	SD	PD	W	/S
		Туре	r	rwh	rwh	rw	rw	rwh	r	w
B5 _H	PMCON1 Reset: 00 _H Power Mode Control Register 1	Bit Field			0		T2_DIS	CCU _DIS	SSC _DIS	ADC _DIS
		Туре			r		rw	rw	rw	rw
B6 _H	OSC_CON Reset: 08 _H OSC Control Register	Bit Field		0		OSC PD	XPD	OSC SS	ORD RES	OSCR
		Туре		r		rw	rw	rw	rwh	rh
B7 _H	PLL_CON Reset: 20 _H PLL Control Register	Bit Field		NI	OIV		VCO BYP	OSC DISC	RESLD	LOCK
		Туре		r	w		rw	rw	rwh	rh
BA _H	CMCON Reset: 00 _H Clock Control Register	Bit Field	VCO SEL		0			CLK	REL	
		Туре	rw		r			r	w	
BB _H	PASSWD Reset: 07 _H Password Register	Bit Field			PASS			PROTE CT_S	МС	DDE
		Туре			w			rh	r	w
BC _H	FEAL Reset: 00 _H	Bit Field			E	CCERR	ADDR[7:	0]		
	Flash Error Address Register Low	Туре					h .			
BD _H	FEAH Reset: 00 _H	Bit Field			E	CCERRA	ADDR[15	:8]		
	Flash Error Address Register High	Туре					h			
BE _H	COCON Reset: 00 _H Clock Output Control Register	Bit Field	(0	TLEN	COUT		СО	REL	
		Туре		r	rw	rw		r	w	
E9 _H	MISC_CON Reset: 00 _H Miscellaneous Control Register	Bit Field				0			DFLAS HEN	
		Туре				r		-		rwh
RMAP =	: 0, Page 3									
B3 _H	XADDRH Reset: F0 _H	Bit Field				AD	DRH			
	On-Chip XRAM Address Higher Order	Туре				r	W	-		

The WDT SFRs can be accessed in the mapped memory area (RMAP = 1).

Table 7 WDT Register Overview

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
RMAP =	1	Į.				!			!	
BB _H	WDTCON Reset: 00 ₁ Watchdog Timer Control Register	Bit Field		0	WINB EN	WDT PR	0	WDT EN	WDT RS	WDT IN
		Type		r	rw	rh	r	rw	rwh	rw
BC _H	WDTREL Reset: 00	Bit Field				WDT	REL			
	Watchdog Timer Reload Register	Type				r	N		RS	
BD _H	WDTWINB Reset: 00 ₁ Watchdog Window-Boundary Count	Bit Field				WDT	WINB			
	Register	Type				r	N			
BE _H	WDTL Reset: 00 ₁	Bit Field				WDT	[7:0]			
	Watchdog Timer Register Low	Туре				r	h			
BF _H	WDTH Reset: 00	Bit Field				WDT	[15:8]			
	Watchdog Timer Register High	Туре				r	h			



The Port SFRs can be accessed in the standard memory area (RMAP = 0).

Table 8 Port Register Overview

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
RMAP =	0									
B2 _H	PORT_PAGE Reset: 00	Bit Field	C)P	ST	NR	0		PAGE	
	Page Register for PORT	Туре	,	w	,	N	r		rwh	
RMAP =	0, Page 0		1							-
80 _H	P0_DATA Reset: 00	Bit Field		0	P5	P4	P3	P2	P1	P0
	P0 Data Register	Туре		r	rwh	rwh	rwh	rwh	rwh	rwh
86 _H	P0_DIR Reset: 00	Bit Field		0	P5	P4	P3	P2	P1	P0
	P0 Direction Register	Туре		r	rw	rw	rw	rw	rw	rw
90 _H	P1_DATA Reset: 00	Bit Field	P7	P6	P5		0		P1	P0
	P1 Data Register	Type	rwh	rwh	rwh		r		rwh	rwh
91 _H	P1_DIR Reset: 00	Bit Field	P7	P6	P5		0		P1	P0
	P1 Direction Register	Туре	rw	rw	rw		r		rw	rw
A0 _H	P2_DATA Reset: 00	Bit Field	P7	P6	P5	P4	P3	P2	P1	P0
	P2 Data Register	Type	rwh							
A1 _H	P2_DIR Reset: 00		P7	P6	P5	P4	P3	P2	P1	P0
	P2 Direction Register	Туре	rw							
B0 _H	P3_DATA Reset: 00	•	P7	P6	P5	P4	P3	P2	P1	P0
	P3 Data Register	Type	rwh							
B1 _H	P3_DIR Reset: 00	•	P7	P6	P5	P4	P3	P2	P1	P0
	P3 Direction Register	Type	rw							
	0, Page 1									
80 _H	P0_PUDSEL Reset: FF			0	P5	P4	P3	P2	P1	P0
	P0 Pull-Up/Pull-Down Select Registe	1 9 P C		r	rw	rw	rw	rw	rw	rw
86 _H	P0_PUDEN Reset: C4			0	P5	P4	P3	P2	P1	P0
	P0 Pull-Up/Pull-Down Enable Regist	1 9 P C		r	rw	rw	rw	rw	rw	rw
90 _H	P1_PUDSEL Reset: FF		P7	P6	P5		0		P1	P0
	P1 Pull-Up/Pull-Down Select Registe	1 9 00	rw	rw	rw		r		rw	rw
91 _H	P1_PUDEN Reset: FF ₁ P1 Pull-Up/Pull-Down Enable Regist		P7	P6	P5		0		P1	P0
		1 9 P C	rw	rw	rw		r		rw	rw
A0 _H	P2_PUDSEL Reset: FF ₁ P2 Pull-Up/Pull-Down Select Register		P7	P6	P5	P4	P3	P2	P1	P0
	·	турс	rw							
A1 _H	P2_PUDEN Reset: 00 P2 Pull-Up/Pull-Down Enable Regist		P7	P6	P5	P4	P3	P2	P1	P0
		1 9 P C	rw							
B0 _H	P3_PUDSEL Reset: BF ₁ P3 Pull-Up/Pull-Down Select Register		P7	P6	P5	P4	P3	P2	P1	P0
D4		1 9 P C	rw P7	rw P6	rw P5	rw	rw P3	rw P2	rw P1	rw
B1 _H	P3_PUDEN Reset: 40 P3 Pull-Up/Pull-Down Enable Regist			-	-	P4				P0
DMAD	0, Page 2	er Type	rw							
	P0 ALTSEL0 Reset: 00	Bit Field		0	P5	P4	P3	P2	P1	P0
80 _H	P0_ALTSEL0 Reset: 00 P0 Alternate Select 0 Register	Type					rw		rw	_
96	P0 ALTSEL1 Reset: 00	71		r 0	rw P5	rw P4	P3	rw P2	P1	rw P0
86 _H	P0_ALTSELT Reset: 00 P0 Alternate Select 1 Register	Type		r	rw	rw	rw	rw	rw	rw
90 _H	P1 ALTSEL0 Reset: 00		P7	P6	P5	I VV	0	1 44	P1	P0
30H	P1 Alternate Select 0 Register	Type	rw	rw	rw		r		rw	rw
91 _H	P1 ALTSEL1 Reset: 00	71	P7	P6	P5		0		P1	P0
3 TH	P1 Alternate Select 1 Register	Type	rw	rw	rw		r		rw	rw
B0 _H	P3 ALTSEL0 Reset: 00		P7	P6	P5	P4	P3	P2	P1	P0
DOH	P3 Alternate Select 0 Register	Type	rw							
		Турс	1 44	1 44	1 44	1 44	1 44	1 44	1 44	1 44



Table 8 Port Register Overview (cont'd)

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
B1 _H	P3_ALTSEL1 Reset: 00 _H	Bit Field	P7	P6	P5	P4	P3	P2	P1	P0
	P3 Alternate Select 1 Register	Туре	rw	rw	rw	rw	rw	rw	rw	rw
RMAP =	0, Page 3									
80 _H	P0_OD Reset: 00 _H P0 Open Drain Control Register	Bit Field	()	P5	P4 P3 P2			P1	P0
		Туре		r	rw	rw	rw	rw	rw	rw
90 _H	P1_OD Reset: 00 _H	Bit Field	P7	P6	P5		0		P1	P0
	P1 Open Drain Control Register	Туре	rw	rw	rw		r		rw	rw
B0 _H	P3_OD Reset: 00 _H	Bit Field	P7	P6	P5	P4	P3	P2	P1	P0
	P3 Open Drain Control Register	Туре	rw	rw	rw	rw	rw	rw	rw	rw

The ADC SFRs can be accessed in the standard memory area (RMAP = 0).

Table 9 ADC Register Overview

0			_	6	5	4	3	2	1	0	
•							I	I		1	
ADC_PAGE	Reset: 00 _H	Bit Field	OP STNR			0	PAGE				
Page Register for ADC		Туре	,	N	,	N	r		rwh		
0, Page 0				U.							
ADC_GLOBCTR Reset: 30 _H		Bit Field	ANON	DW	CTC			(0		
Global Control Register		Туре	rw	rw	r	w					
ADC_GLOBSTR Reset: 00 _H Global Status Register		Bit Field		0		CHNR		0	SAM PLE	BUSY	
		Туре		r		rh		r	rh	rh	
ADC_PRAR	Reset: 00 _H	Bit Field	ASEN1	ASEN0	0	ARBM	CSM1	PRIO1	CSM0	PRIO0	
Priority and Arbitration Re	egister	Туре	rw	rw	r	rw	rw	rw	rw	rw	
ADC_LCBR	Reset: B7 _H	Bit Field		BOU	ND1			BOUND0			
Limit Check Boundary Re	egister	Туре		r۱	v			г	w		
CE _H ADC_INPCR0 Reset: 00 _H Input Class Register 0		Bit Field	STC								
		Туре				w					
ADC_ETRCR Reset: 00 _H External Trigger Control Register		Bit Field	SYNEN 1	SYNEN ETRSEL1			1 ETRSEL0				
		Туре	rw	rw		rw		rw			
0, Page 1								I		-	
ADC_CHCTR0 Reset: 00 _H		Bit Field	0		LCC		0		RES	RSEL	
Channel Control Register	0	Туре	r	rw		r		r	w		
ADC_CHCTR1	Reset: 00 _H	Bit Field	0		LCC		0		RESRSEL		
Channel Control Register	r 1	Туре	r		rw		r		rw		
ADC_CHCTR2	Reset: 00 _H	Bit Field	0	LCC		0		RESRSEL			
Channel Control Register	12	Туре	r		rw			r	rw		
ADC_CHCTR3	Reset: 00 _H	Bit Field	0		LCC		0		RESRSEL		
Channel Control Register	13	Туре	r		rw		r		rw		
ADC_CHCTR4	Reset: 00 _H	Bit Field	0	LCC			0		RESRSEL		
Channel Control Register	r 4	Туре	r		rw			r		rw	
ADC_CHCTR5	Reset: 00 _H	Bit Field	0	LCC		0		RESRSEL			
Channel Control Register	ol Register 5 Type r rw			r		rw					
ADC_CHCTR6	Reset: 00 _H	Bit Field	0	LCC			0		RESRSEL		
· ·	16	Туре	r	rw			r		rw		
ADC_CHCTR7	Reset: 00 _H	Bit Field	0		LCC		0		RESRSEL		
Channel Control Register	17	Туре	r	· rw				r rw			
	ADC_CHCTR2 Channel Control Register ADC_CHCTR3 ADC_CHCTR4 ADC_INPCR0 Input Class Register O ADC_CHCTR1 ADC_CHCTR2 Channel Control Register ADC_CHCTR1 Channel Control Register ADC_CHCTR2 Channel Control Register ADC_CHCTR3 Channel Control Register ADC_CHCTR4 Channel Control Register ADC_CHCTR5 Channel Control Register ADC_CHCTR1 Channel Control Register ADC_CHCTR2 Channel Control Register ADC_CHCTR3 Channel Control Register ADC_CHCTR4 Channel Control Register ADC_CHCTR5 Channel Control Register ADC_CHCTR6 Channel Control Register	ADC_GLOBSTR ADC_GLOBSTR Global Status Register ADC_GRAR Reset: 00 _H Priority and Arbitration Register ADC_INPCR0 ADC_ETRCR ADC_ETRCR ADC_ETRCR ADC_ETRCR ADC_ETRCR ADC_ETRCR ADC_ETRCR ADC_ETRCR ADC_ETRCR ADC_CHCTR1 ADC_CHCTR1 ADC_CHCTR1 ADC_CHCTR2 ADC_CHCTR2 ADC_CHCTR3 ADC_CHCTR3 ADC_CHCTR3 ADC_CHCTR4 Channel Control Register ADC_CHCTR4 Channel Control Register 3 ADC_CHCTR4 Channel Control Register 4 ADC_CHCTR5 Reset: 00 _H Channel Control Register 5 ADC_CHCTR5 Reset: 00 _H Channel Control Register 4 ADC_CHCTR6 Reset: 00 _H Channel Control Register 5 ADC_CHCTR7 Reset: 00 _H Channel Control Register 4 ADC_CHCTR6 Reset: 00 _H Channel Control Register 5 ADC_CHCTR6 Reset: 00 _H Channel Control Register 6	ADC_GLOBSTR Reset: 00H Sit Field Type ADC_GLOBSTR Reset: 00H Sit Field Type ADC_PRAR Reset: 00H Sit Field Type ADC_LCBR Reset: 00H Sit Field Type ADC_LCBR Reset: 00H Sit Field Type ADC_LCBR Reset: 00H Sit Field Type ADC_INPCR0 Reset: 00H Sit Field Type ADC_ETRCR Reset: 00H Sit Field Type ADC_ETRCR Reset: 00H Sit Field Type ADC_CHCTR0 Reset: 00H Sit Field Type ADC_CHCTR1 Reset: 00H Channel Control Register 1 ADC_CHCTR2 Reset: 00H Sit Field Type ADC_CHCTR3 Reset: 00H Sit Field Type ADC_CHCTR4 Reset: 00H Sit Field Type ADC_CHCTR4 Reset: 00H Sit Field Type ADC_CHCTR4 Reset: 00H Sit Field Type ADC_CHCTR5 Reset: 00H Sit Field Type ADC_CHCTR6 Reset: 00H Sit Field Type ADC_CHCTR7 Reset: 00H Sit Field Type ADC_CHCTR8 Reset: 00H Sit Field Type ADC_CHCTR8 Reset: 00H Sit Field Type ADC_CHCTR4 Reset: 00H Sit Field Type ADC_CHCTR5 Reset: 00H Sit Field Type ADC_CHCTR5 Reset: 00H Sit Field Type ADC_CHCTR6 Reset: 00H Sit Field Type ADC_CHCTR6 Reset: 00H Sit Field Type ADC_CHCTR7 Reset: 00H Sit Field Type ADC_CHCTR6 Reset: 00H Sit Field Type ADC_CHCTR7 Reset: 00H Sit Field Type ADC_CHCTR8 Reset: 00H Sit Field Type ADC_CHCTR8 Reset: 00H Sit Field Type ADC_CHCTR7 Reset: 00H Sit Field Type ADC_CHCTR8 Reset: 00H Sit Field Type ADC_CHCTR8 Reset: 00H Sit Field Type ADC_CHCTR8 Reset: 00H Sit Field Type ADC_CHCTR7 Reset: 00H Sit Field Type	ADC_GLOBSTR Global Status Register ADC_GLOBSTR Global Status Register ADC_PRAR Priority and Arbitration Register ADC_LCBR Limit Check Boundary Register ADC_INPCR0 Reset: 87H Limit Class Register 0 ADC_ETRCR External Trigger Control Register ADC_CHCTR1 Channel Control Register 1 ADC_CHCTR2 Reset: 00H Channel Control Register 2 ADC_CHCTR3 Reset: 00H Channel Control Register 1 ADC_CHCTR4 Reset: 00H Channel Control Register 2 ADC_CHCTR5 Reset: 00H Channel Control Register 3 ADC_CHCTR4 Reset: 00H Channel Control Register 4 ADC_CHCTR5 Reset: 00H Channel Control Register 5 ADC_CHCTR5 Reset: 00H Channel Control Register 6 ADC_CHCTR6 Reset: 00H Channel Control Register 7 ADC_CHCTR7 Reset: 00H Channel Control Register 8 Reset: 00H Channel Control Register 9 ADC_CHCTR4 Reset: 00H Channel Control Register 6 Bit Field Channel Control Register 6 Reset: 00H Channel Control Register 6 Bit Field Channel Control Register 6 Reset: 00H Channel Control Register 6 Bit Field Channel Control Register 6	ADC_GLOBSTR Reset: 30H Bit Field ASEN1 ASEN0 Priority and Arbitration Register ADC_LCBR Reset: 87H Limit Check Boundary Register ADC_INPCR0 Reset: 00H R	ADC_GLOBSTR Global Status Register ADC_GLOBSTR Reset: 00H Priority and Arbitration Register ADC_LCBR Limit Check Boundary Register ADC_INPCR0 Reset: 00H Input Class Register 0 ADC_ETRCR External Trigger Control Register ADC_CHCTR0 Channel Control Register 1 ADC_CHCTR1 Reset: 00H ADC_CHCTR2 Reset: 00H Reset: 00H Bit Field Type Tw Type Type Tw Type Type Type Type Type Type Type Typ	ADC_GLOBSTR Reset: 30H Bit Field NNON DW CTC Type rw rw rw ADC_GLOBSTR Reset: 00H Priority and Arbitration Register ADC_LCBR Reset: 00H Limit Check Boundary Register ADC_INPCR0 Reset: 00H Retermine Type rw rw rw r rw ADC_ETRCR Reset: 00H External Trigger Control Register ADC_CHCTR1 Reset: 00H Channel Control Register 1 ADC_CHCTR2 Reset: 00H Bit Field 0 LCC Type rw rw rw rw rw ADC_CHCTR3 Reset: 00H Bit Field 0 LCC Type rw ADC_CHCTR4 Reset: 00H Bit Field 0 LCC Type rw ADC_CHCTR5 Reset: 00H Bit Field 0 LCC Type rw ADC_CHCTR6 Reset: 00H Bit Field 0 LCC Type rw ADC_CHCTR7 Reset: 00H Bit Field 0 LCC Type rw ADC_CHCTR8 Reset: 00H Bit Field 0 LCC Type rw ADC_CHCTR1 Reset: 00H Bit Field 0 LCC Type r rw ADC_CHCTR4 Reset: 00H Bit Field 0 LCC Type r rw ADC_CHCTR4 Reset: 00H Channel Control Register 3 ADC_CHCTR5 Reset: 00H Channel Control Register 4 ADC_CHCTR5 Reset: 00H Channel Control Register 5 ADC_CHCTR6 Reset: 00H Channel Control Register 6 ADC_CHCTR7 Reset: 00H Channel Control Register 6 Bit Field 0 LCC Type r rw ADC_CHCTR6 Reset: 00H Channel Control Register 6 Bit Field 0 LCC Type r rw ADC_CHCTR6 Reset: 00H Channel Control Register 6 Bit Field 0 LCC Type r rw ADC_CHCTR6 Reset: 00H Channel Control Register 6 Bit Field 0 LCC Type r rw ADC_CHCTR7 Reset: 00H Channel Control Register 6 Bit Field 0 LCC Type r rw ADC_CHCTR6 Reset: 00H Channel Control Register 6 Bit Field 0 LCC Type r rw ADC_CHCTR7 Reset: 00H Channel Control Register 6 Bit Field 0 LCC Type r rw ADC_CHCTR7 Reset: 00H Channel Control Register 6 Bit Field 0 LCC Type r rw ADC_CHCTR7 Reset: 00H Channel Control Register 6	ADC_GLOBSTR Reset: 00H Global Status Register ADC_GRAR Reset: 00H Priority and Arbitration Register ADC_LCBR Reset: 00H Limit Check Boundary Register ADC_INPCR0 Reset: 00H Register On Input Class	ADC_GLOBCTR Global Control Register ADC_GLOBSTR Global Status Register ADC_PRAR Reset: 00 _H Priority and Arbitration Register ADC_LCBR Limit Check Boundary Register ADC_INPCR0 Reset: 00 _H Input Class Register ADC_ETRCR External Trigger Control Register ADC_CHCTR0 Channel Control Register 1 ADC_CHCTR1 ADC_CHCTR1 Reset: 00 _H Channel Control Register 2 ADC_CHCTR3 Reset: 00 _H Channel Control Register 3 ADC_CHCTR4 Reset: 00 _H Channel Control Register 4 ADC_CHCTR4 Reset: 00 _H Channel Control Register 5 ADC_CHCTR5 Reset: 00 _H Channel Control Register 6 ADC_CHCTR6 Reset: 00 _H Channel Control Register 7 ADC_CHCTR7 Reset: 00 _H Channel Control Register 8 Bit Field 0 Type rw rw rw rw Type rw rw rw Type r rw Type	ADC_GLOBSTR Reset: 00H Global Status Register ADC_GLOBSTR Reset: 00H Priority and Arbitration Register ADC_DRAR Reset: 00H Priority and Arbitration Register ADC_LCBR Reset: 00H It Field ASEN1 ASEN0	



Table 9 ADC Register Overview (cont'd)

Addr	Register Name		Bit	7	6	5	4	3	2	1	0			
CA _H	ADC_RESR0L	Reset: 00 _H	Bit Field	RESUI	LT[1:0]	0	VF	DRC		CHNR	1			
1	Result Register 0 Low		Туре	r	rh r			rh		rh				
CB _H	ADC_RESR0H	Reset: 00 _H	Bit Field	d RESULT[9:2]										
	Result Register 0 High		Туре				r	h						
CCH	ADC_RESR1L	Reset: 00 _H	Bit Field	RESUI	LT[1:0]	0	VF	DRC CH		CHNR				
İ	Result Register 1 Low		Туре	r	h	r	rh	rh rh		rh				
CD _H	ADC_RESR1H	Reset: 00 _H	Bit Field				RESU	LT[9:2]						
1	Result Register 1 High		Туре				r	h						
CE _H	ADC_RESR2L	Reset: 00 _H	Bit Field	RESUI	LT[1:0]	0	VF	DRC CHN		CHNR				
İ	Result Register 2 Low		Туре	r	h	r	rh	rh		rh				
CF _H	ADC_RESR2H	Reset: 00 _H	Bit Field				RESU	LT[9:2]						
İ	Result Register 2 High		Туре				r	h						
D2 _H	ADC_RESR3L	Reset: 00 _H	Bit Field	RESUI	LT[1:0]	0	VF	DRC		CHNR				
	Result Register 3 Low		Type	r	h	r	rh	rh		rh				
D3 _H	ADC_RESR3H	Reset: 00 _H	Bit Field				RESU	LT[9:2]						
	Result Register 3 High		Туре				r	h						
RMAP =	0, Page 3													
CA _H	ADC_RESRA0L	Reset: 00 _H	Bit Field	RESULT[2:0]			VF	DRC		CHNR				
	Result Register 0, View A		Type Bit Field	rh			rh	rh		rh				
CB _H	ADC_RESRA0H			RESULT[10:3]										
	Result Register 0, View A		Type	rh RESULT[2:0] VF DRC CHNR										
CCH	ADC_RESRA1L Reset: 00 _H		Bit Field	RE	RESULT[2:0]			DRC CHNR						
	Result Register 1, View A		Туре		rh		rh	rh		rh				
CD _H	ADC_RESRA1H Reset:		Bit Field		RESULT[10:3]									
	Result Register 1, View A	Type Bit Field	rh											
CEH		ADC_RESRA2L Reset: 00 _H		RESULT[2:0]			VF	DRC						
	Result Register 2, View A		Type	rh			rh	rh rh						
CF _H	ADC_RESRA2H Result Register 2, View A	Reset: 00 _H	Bit Field	RESULT[10:3]										
	•		Туре					h						
D2 _H	ADC_RESRA3L Result Register 3, View A	Reset: 00 _H	Bit Field	RE	SULT[2	:0]	VF	DRC		CHNR				
	•		Туре		rh		rh	rh		rh				
D3 _H	ADC_RESRA3H Result Register 3, View A	Reset: 00 _H	Bit Field					_T[10:3]						
D144B	•	v i ligii	Туре				r	h						
	0, Page 4	D(: 00	Bit Field	VFCTR	WFR	0	IEN		0		DRCT			
CA _H	Result Control Register 0	Reset: 00 _H	Bit Fleid	VECIR	WFK	U	IEIN		U		R			
			Туре	rw	rw	r	rw		r		rw			
СВн	ADC RCR1	Reset: 00 _H	Bit Field	VFCTR	WFR	0	IEN		0		DRCT			
	Result Control Register 1						1				R			
			Туре	rw	rw	r	rw		r		rw			
CCH	ADC_RCR2 Result Control Register 2	Reset: 00 _H	Bit Field	VFCTR	WFR	0	IEN		0		DRCT R			
	Nesult Control Register 2		Туре	rw	rw	г	rw		r		rw			
CD _H	ADC_RCR3	Reset: 00 _H	Bit Field	VFCTR	WFR	0	IEN		0		DRCT			
ODH	Result Control Register 3		Dit i lolu	VI OIK	*****	U	ILIV		U		R			
	Jana		Туре	rw	rw	r	rw		r		rw			
CE _H	ADC_VFCR	Reset: 00 _H	Bit Field		(1	VFC3	VFC2	VFC1	VFC0			
	Valid Flag Clear Register		Туре			,		w	w	w	w			
RMAP =	0, Page 5			-1				1	1	l .	1			



Table 9 ADC Register Overview (cont'd)

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
CA _H	ADC_CHINFR Reset: 00 _H Channel Interrupt Flag Register	Bit Field	CHINF 7	CHINF 6	CHINF 5	CHINF 4	CHINF 3	CHINF 2	CHINF 1	CHINF 0
		Туре	rh							
CB _H	ADC_CHINCR Reset: 00 _H Channel Interrupt Clear Register	Bit Field	CHINC 7	CHINC 6	CHINC 5	CHINC 4	CHINC 3	CHINC 2	CHINC 1	CHINC 0
		Type	w	w	w	W	w	w	w	w
CCH	ADC_CHINSR Reset: 00 _H Channel Interrupt Set Register	Bit Field	CHINS 7	CHINS 6	CHINS 5	CHINS 4	CHINS 3	CHINS 2	CHINS 1	CHINS 0
		Type	w	w	w	w	w	w	w	w
CD _H	ADC_CHINPR Reset: 00 _H Channel Interrupt Node Pointer	Bit Field	CHINP 7	CHINP 6	CHINP 5	CHINP 4	CHINP 3	CHINP 2	CHINP 1	CHINP 0
	Register	Туре	rw							
CEH	ADC_EVINFR Reset: 00 _H Event Interrupt Flag Register	Bit Field	EVINF 7	EVINF 6	EVINF 5	EVINF 4	(0	EVINF 1	EVINF 0
		Type	rh	rh	rh	rh	r		rh	rh
CF _H	ADC_EVINCR Reset: 00 _H Event Interrupt Clear Flag Register	Bit Field	EVINC 7	EVINC 6	EVINC 5	EVINC 4	0		EVINC 1	EVINC 0
		Type	w	w	w	w			w	w
D2 _H	ADC_EVINSR Reset: 00 _H Event Interrupt Set Flag Register	Bit Field	EVINS 7	EVINS 6	EVINS 5	EVINS 4	0		EVINS 1	EVINS 0
		Type	w	w	w	W		r	w	w
D3 _H	ADC_EVINPR Reset: 00 _H Event Interrupt Node Pointer Register	Bit Field	EVINP 7	EVINP 6	EVINP 5	EVINP 4	0		EVINP 1	EVINP 0
		Type	rw	rw	rw	rw	r		rw	rw
RMAP =	0, Page 6									
CA _H	ADC_CRCR1 Reset: 00 _H Conversion Request Control Register 1	Bit Field	CH7	CH6	CH5	CH4	0			
		Туре	rwh	rwh	rwh	rwh	r			
CB _H	ADC_CRPR1 Reset: 00 _H Conversion Request Pending	Bit Field	CHP7	CHP6	CHP5	CHP4		()	
	Register 1	Туре	rwh	rwh	rwh	rwh			r	
CCH	ADC_CRMR1 Reset: 00 _H Conversion Request Mode Register 1	Bit Field	Rsv	LDEV	CLR PND	SCAN	ENSI	ENTR	EN	IGT
		Туре	r	w	w	rw	rw	rw		w
CD _H	ADC_QMR0 Reset: 00 _H	Bit Field	CEV	TREV	FLUSH	CLRV	TRMD	ENTR	EN	IGT
	Queue Mode Register 0	Туре	w	w	w	w	rw	rw		w
CEH	ADC_QSR0 Reset: 20 _H	Bit Field	Rsv	0	EMPTY	EV		0		
	Queue Status Register 0	Туре	r	r	rh	rh			r	
CF _H	ADC_Q0R0 Reset: 00 _H	Bit Field	EXTR	ENSI	RF	٧	0	R	EQCHN	R
	Queue 0 Register 0	Туре	rh	rh	rh	rh	r		rh	
D2 _H	ADC_QBUR0 Reset: 00 _H	Bit Field	EXTR	ENSI	RF	V	0	R	EQCHN	R
	Queue Backup Register 0	Туре	rh	rh	rh	rh	r	rh		
D2 _H	ADC_QINR0 Reset: 00 _H	Bit Field Type	EXTR	ENSI	RF)	REQCHNR		
	Queue Input Register 0		w	w	w	1	r	W		

The Timer 2 SFRs can be accessed in the standard memory area (RMAP = 0).

Table 10 Timer 2 Register Overview

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
C0 _H	T2_T2CON Timer 2 Control Register	Bit Field	TF2	EXF2		0	EXEN2	TR2	0	CP/ RL2
		Туре	rwh	rwh		r	rw	rwh	r	rw



Table 10 Timer 2 Register Overview (cont'd)

C1 _H	T2_T2MOD Timer 2 Mode Register	Reset: 00 _H	Bit Field	T2 REGS	T2 RHEN	EDGE SEL	PREN	T2PRE	DCEN	
			Туре	rw	rw	rw	rw	rw	rw	
C2 _H	T2_RC2L	Reset: 00 _H	Bit Field				RC2	[7:0]		
	Timer 2 Reload/Capture	imer 2 Reload/Capture Register Low		rwh						
C3 _H	T2_RC2H			RC2[15:8]						
	Timer 2 Reload/Capture	Register High	Туре	rwh						
C4 _H	T2_T2L	Reset: 00 _H	Bit Field	THL2[7:0]						
	Timer 2 Register Low		Туре				rv	/h		
C5 _H	T2_T2H	Reset: 00 _H	Bit Field				THL2	[15:8]		
	Timer 2 Register High		Туре				rv	/h		

The CCU6 SFRs can be accessed in the standard memory area (RMAP = 0).

Table 11 CCU6 Register Overview

Addr	Register Name	Bit	7	6	5	4	3	2	1	0	
RMAP =	0										
A3 _H	CCU6_PAGE Reset: 00 _H	Bit Field	C)P	ST	NR	0		PAGE		
	Page Register for CCU6	Туре	w w r rwh								
RMAP =	0, Page 0										
9A _H	CCU6_CC63SRL Reset: 00 _H Capture/Compare Shadow Register for	Bit Field				CC6	3SL				
	Channel CC63 Low	Туре	rw								
9B _H	CCU6_CC63SRH Reset: 00 _H Capture/Compare Shadow Register for	Bit Field				CC6	3SH				
	Channel CC63 High	Type		rw							
9C _H	CCU6_TCTR4L Reset: 00 _H Timer Control Register 4 Low	Bit Field	T12 STD	T12 STR	(0	DTRES	T12 RES	T12RS	T12RR	
		Type Bit Field	w	w		r	w	w	w	w	
9D _H	CCU6_TCTR4H Reset: 00 _H Timer Control Register 4 High		T13 STD	T13 STR	0			T13 RES	T13RS	T13RR	
		Туре	w	w		r		w	w	w	
9E _H	CCU6_MCMOUTSL Reset: 00 _H Multi-Channel Mode Output Shadow	Bit Field	STRM CM	0			MCI	MPS		,	
	Register Low	Туре	w	r	rw						
9F _H	CCU6_MCMOUTSH Reset: 00 _H	Bit Field	STRHP	0					EXPHS		
	Multi-Channel Mode Output Shadow Register High	Туре	W	r	rw			rw			
A4 _H	CCU6_ISRL Reset: 00 _H Capture/Compare Interrupt Status	Bit Field	RT12P M	RT12O M	RCC62 F	RCC62 R	RCC61 F	RCC61 R	RCC60 F	RCC60 R	
	Reset Register Low	Туре	w	w	w	w	w	w	w	w	
A5 _H	CCU6_ISRH Reset: 00 _H Capture/Compare Interrupt Status	Bit Field	RSTR	RIDLE	RWHE	RCHE	0	RTRPF	RT13 PM	RT13 CM	
	Reset Register High	Type	w	w	w	w	r	w	w	w	
A6 _H	CCU6_CMPMODIFL Reset: 00 _H Compare State Modification Register	Bit Field	0	MCC63 S		0		MCC62 S	MCC61 S	MCC60 S	
	Low	Type	r	w		r		w	w	w	
A7 _H	CCU6_CMPMODIFH Reset: 00 _H Compare State Modification Register	Bit Field	0	MCC63 R		0		MCC62 R	MCC61 R	MCC60 R	
	High	Type Bit Field	r	w		r		w	w	w	
FA _H	Capture/Compare Shadow Register for					CC	60SL				
	0	Туре				rv	vh				



Table 11 CCU6 Register Overview (cont'd)

Addr	Register Name	Bit	7	6	5	4	3	2	1	0	
FB _H	CCU6_CC60SRH Reset: 00 _H Capture/Compare Shadow Register for	Bit Field				CC6	0SH				
	Channel CC60 High	Туре				rv	vh				
FC _H	CCU6_CC61SRL Reset: 00 _H Capture/Compare Shadow Register for	Bit Field				CC6	S1SL				
	Channel CC61 Low	Type				rv	vh				
FD _H	CCU6_CC61SRH Reset: 00 _H Capture/Compare Shadow Register for	Bit Field CC61SH									
	Channel CC61 High	Type rwh									
FE _H	CCU6_CC62SRL Reset: 00 _H Capture/Compare Shadow Register for Channel CC62 Low	Bit Field CC62SL									
		Туре									
FF _H	CCU6_CC62SRH Reset: 00 _H Capture/Compare Shadow Register for Channel CC62 High	Bit Field					2SH				
DMAAD	, and the second	Туре				rv	vn				
9A _H	0, Page 1 CCU6_CC63RL Reset: 00 _H	Bit Field				CC6	3VL				
	Capture/Compare Register for Channel CC63 Low	Type				-	h				
9B _H	CCU6_CC63RH Reset: 00 _H	Type Bit Field	rh								
эрH	Capture/Compare Register for Channel CC63 High										
00	· · ·	Type									
9C _H	CCU6_T12PRL Reset: 00 _H Timer T12 Period Register Low	Bit Field Type				rv	PVL				
9D _H	CCU6 T12PRH Reset: 00 _H	Bit Field					vn PVH				
apH	Timer T12 Period Register High	Type				rv					
9E _H	CCU6 T13PRL Reset: 00 _H	Bit Field T13PVL									
3EH	Timer T13 Period Register Low	Type rwh									
9F _H	CCU6 T13PRH Reset: 00 _H	Bit Field T13PVH									
or H	Timer T13 Period Register High	Type rwh									
A4 _H	CCU6 T12DTCL Reset: 00 _H	Bit Field DTM									
АН	Dead-Time Control Register for Timer T12 Low	Туре	rw								
A5 _H	CCU6_T12DTCH Reset: 00 _H Dead-Time Control Register for Timer	Bit Field	0	DTR2	DTR1	DTR0	0	DTE2	DTE1	DTE0	
	T12 High	Туре	r	rh	rh	rh	r	rw	rw	rw	
A6 _H	CCU6_TCTR0L Reset: 00 _H Timer Control Register 0 Low	Bit Field	СТМ	CDIR	STE12	T12R	T12 PRE		T12CLK		
		Type	rw	rh	rh	rh	rw		rw		
A7 _H	CCU6_TCTR0H Reset: 00 _H Timer Control Register 0 High	Bit Field	()	STE13	T13R	T13 PRE		T13CLK		
		Туре	1	r	rh	rh	rw		rw		
FA _H	CCU6_CC60RL Reset: 00 _H Capture/Compare Register for Channel	Bit Field				CC6	60VL				
	CC60 Low	Туре				r					
FB _H	CCU6_CC60RH Reset: 00 _H Capture/Compare Register for Channel	Bit Field					60VH				
	CC60 High	Туре				r					
FC _H	CCU6_CC61RL Reset: 00 _H Capture/Compare Register for Channel	Bit Field				CC6					
	CC61 Low	Type				r	h				



Table 11 CCU6 Register Overview (cont'd)

Capture/Compare Interrupt Enable PM OM 62F 62R 61F	MSEL rw MSEL rw ENCC [61R] rw	/ L62	
FEH COU6_CC62RL Reset: 00H Capture/Compare Register for Channel CC62 Low FFH CAUST CC62RH Reset: 00H CAUST CC62 Ligh FFH CAUST CC62RH Reset: 00H CAUST CC62 Ligh FFH CAUST CC62 Ligh FFH COU6_CC62RH Reset: 00H CAUST CC62 Ligh FFH CAUST C	rw MSEL rw ENCC 61R	/ L62	
Capture/Compare Register for Channel CC62 Low	rw MSEL rw ENCC 61R	/ L62	
FFH	rw MSEL rw ENCC 61R	/ L62	
Capture/Compare Register for Channel CC62 High Type Th	rw MSEL rw ENCC 61R	/ L62	
RMAP = 0, Page 2	rw MSEL rw ENCC 61R	/ L62	
9A _H CCU6_T12MSELL	rw MSEL rw ENCC 61R	/ L62	
T12 Capture/Compare Mode Select Register Low	rw MSEL rw ENCC 61R	/ L62	
	rw ENCC 61R	L62	
T12 Capture/Compare Mode Select Register High	rw ENCC E 61R		
9CH CCU6_IENL Capture/Compare Interrupt Enable Register Low Reset: 00H Enable Bit Field ENT12_ENT12_ENT12_ENCC_ENCC_ENCC_ENCC_ENCC_ENCC_ENCC_ENC	ENCC 61R		
Capture/Compare Interrupt Enable Register Low	61R	W ENCC ENCC	
9DH CCU6_IENH Reset: 00H Capture/Compare Interrupt Enable Register High Bit Field ENSTR EN IDLE WHE CHE Type rw rw rw rw rw rw rw rw capture/Compare Interrupt Node ENTRY INPCC62 INPCC		60F	60R rw
Capture/Compare Interrupt Enable Register High Type rw rw rw rw rw rw rw r PSEH Capture/Compare Interrupt Node Reset: 40H Capture/Captur		ENT13	ENT13
9E _H CCU6_INPL Reset: 40 _H Bit Field INPCHE INPCC62 INPCC	TRPF	PM	CM
Capture/Compare Interrupt Node	rw	rw	rw
Folitier Register Low Type rw rw rw			CC60
		r۱	
9F _H CCU6_INPH Reset: 39 _H Bit Field 0 INPT13 INPT Capture/Compare Interrupt Node Pointer Register High		INPE	
Type I III		r	
A4 _H CCU6_ISSL Reset: 00 _H Bit Field ST12P ST12O SCC62 SCC61 S C2 Hour Compare Interrupt Status Set Register Low M F R F	R	F	SCC60 R
Type w w w w	w	W	W
A5 _H CCU6_ISSH Reset: 00 _H Bit Field SSTR SIDLE SWHE SCHE SWHC S Register High		ST13 PM	ST13 CM
Type " " " " "	w	W	W
A6 _H CCU6_PSLR Reset: 00 _H Bit Field PSL63 0 PSL Passive State Level Register Type rwh			
Type Tun T		SWSEL	
A7 _H CCU6_MCMCTR Reset: 00 _H Multi-Channel Mode Control Register Bit Field 0 SWSYN 0 Type r r r r	3	rw	
FA _H CCU6_TCTR2L Reset: 00 _H Bit Field 0 T13TED T13TEC Timer Control Register 2 Low		T13 SSC	T12 SSC
Type r rw rw		rw	rw
FB _H CCU6_TCTR2H Reset: 00 _H Bit Field 0 T13RS	SEL	T12R	RSEL
Timer Control Register 2 High Type r rw	,	rv	W
FC _H CCU6_MODCTRL Reset: 00 _H Bit Field MC 0 T12MO Modulation Control Register Low	DDEN		
Type rw r rw	,		
FD _H CCU6_MODCTRH Reset: 00 _H Bit Field ECT13 0 T13MO Modulation Control Register High	DDEN		
Type rw r rw	,		
	TRPM2 T	TRPM1	TRPM0
Trap Control Register Low Type r	rw	rw	



Table 11 CCU6 Register Overview (cont'd)

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
FF _H	CCU6_TRPCTRH Reset: 00 _H Trap Control Register High	Bit Field	TRPPE N	TRPEN 13			TRI	PEN		
		Туре	rw	rw			r	w		
RMAP =	0, Page 3									
9A _H	CCU6_MCMOUTL Reset: 00 _H Multi-Channel Mode Output Register	Bit Field	0	R MCMP						
	Low	Туре	r rh rh							
9B _H	CCU6_MCMOUTH Reset: 00 _H Multi-Channel Mode Output Register	Bit Field	1	0 CURH					EXPH	
	High		r rh						rh	
9C _H	CCU6_ISL Reset: 00 _H Capture/Compare Interrupt Status	Bit Field	T12PM	T12OM	ICC62F	ICC62 R	ICC61F	ICC61 R	ICC60F	ICC60 R
	Register Low		rh	rh	rh	rh	rh	rh	rh	rh
9D _H	Capture/Compare Interrupt Status		STR	IDLE	WHE	CHE	TRPS	TRPF	T13PM	T13CM
	Register High	Туре	rh	rh	rh	rh	rh	rh	rh	rh
9E _H	CCU6_PISEL0L Reset: 00 _H	Bit Field	IST	RP	ISC	C62	ISC	C61	ISC	C60
	Port Input Select Register 0 Low	Туре	r	w	r	w	r	w	r	w
9F _H	CCU6_PISEL0H Reset: 00 _H Port Input Select Register 0 High			OS1	ISP	OS0				
		Туре	rw rw rw						r	w
A4 _H	CCU6_PISEL2 Reset: 00 _H	Bit Field	0 IST13							3HR
	Port Input Select Register 2	Туре	r rw							
FA _H	CCU6_T12L Reset: 00 _H	Bit Field				T12	CVL		•	
	Timer T12 Counter Register Low	Туре				rv	vh			
FB _H	CCU6_T12H Reset: 00 _H	Bit Field				T12	CVH			
	Timer T12 Counter Register High	Туре				rv	vh			
FC _H	CCU6_T13L Reset: 00 _H	Bit Field				T13	CVL			
	Timer T13 Counter Register Low	Туре				rv	vh			
FD_H	CCU6_T13H Reset: 00 _H	Bit Field				T13	CVH			
	Timer T13 Counter Register High	Туре				rv	vh			
FE _H	CCU6_CMPSTATL Reset: 00 _H Compare State Register Low	Bit Field	0	CC63 ST	CCPO S2	CCPO S1	CCPO S0	CC62 ST	CC61 ST	CC60 ST
		Туре	r	rh	rh	rh	rh	rh	rh	rh
FF _H	CCU6_CMPSTATH Reset: 00 _H Compare State Register High	Bit Field	T13IM	COUT 63PS	COUT 62PS	CC62 PS	COUT 61PS	CC61 PS	COUT 60PS	CC60 PS
		Туре	rwh	rwh	rwh	rwh	rwh	rwh	rwh	rwh

The SSC SFRs can be accessed in the standard memory area (RMAP = 0).

Table 12 SSC Register Overview

Addr	Register Name		Bit	7	6	5	4	3	2	1	0
RMAP =	0			!			!	!		!	
A9 _H			Bit Field			0		CIS	SIS	MIS	
	Port Input Select Regist	er	Туре			r			rw	rw	rw
AA_H	SSC_CONL	Reset: 00 _H	Bit Field	LB	PO	PH	HB		В	M	
	Control Register Low Programming Mode Operating Mode		Туре	rw	rw	rw	rw		r	w	
			Bit Field		0				В	C	
			Туре			r			r	h	



Table 12 SSC Register Overview

AB _H	SSC_CONH Reset: 00 _H Control Register High	Bit Field	EN	MS	0	AREN	BEN	PEN	REN	TEN
	Programming Mode	Туре	rw	rw	г	rw	rw	rw	rw	rw
	Operating Mode	Bit Field	EN	MS	0	BSY	BE	PE	RE	TE
			rw	rw	r	rh	rwh	rwh	rwh	rwh
AC _H	SSC_TBL Reset: 00 _H	Bit Field				TB_V	ALUE			
	Transmitter Buffer Register Low	Туре	rw							
AD _H	SSC_RBL Reset: 00 _H	Bit Field	RB_VALUE							
	Receiver Buffer Register Low	Туре	rh							
AE _H	SSC_BRL Reset: 00 _H	Bit Field	BR_VALUE[7:0]							
	Baudrate Timer Reload Register Low	Туре				r	N			
AF _H	SSC_BRH Reset: 00 _H	Bit Field				BR_VAL	UE[15:8]			
	Baudrate Timer Reload Register High	Туре				r	N			

The OCDS SFRs can be accessed in the mapped memory area (RMAP = 1).

Table 13 OCDS Register Overview

Addr	Register Name	Bit	7	6	5	4	3	2	1	0
RMAP =	1	Į		l		l		l		
E9 _H	MMCR2 Reset: 0U _H Monitor Mode Control Register 2	Bit Field	EXBC_ P	EXBC	MBCO N_P	MBCO N	MMEP _P	MMEP	MMOD E	JENA
		Туре	w	rw	w	rwh	w	rwh	rh	rh
F1 _H	1 _H MMCR Reset: 00 _H Monitor Mode Control Register		MEXIT _P	MEXIT	MSTEP _P	MSTEP	MRAM S_P	MRAM S	TRF	RRF
		Туре	W	rwh	w	rw	w	rwh	rh	rh
F2 _H	MMSR Reset: 00 _H Monitor Mode Status Register	Bit Field	MBCA M	MBCIN	EXBF	SWBF	HWB3 F	HWB2 F	HWB1 F	HWB0 F
		Туре	rw	rh	rwh	rwh	rwh	rwh	rwh	rwh
F3 _H	MMBPCR Reset: 00 _H BreakPoints Control Register	Bit Field	SWBC	HW	ВЗС	HWB2C		HWB1 C	HWB0C	
			rw	r	w	r	w	rw	r	w
F4 _H	MMICR Reset: 00 _H Monitor Mode Interrupt Control Register	Bit Field	DVECT	DRETR	()	MMUIE _P	MMUIE	RRIE_ P	RRIE
		Туре	rwh	rwh		r	w	rw	w	rw
F5 _H	MMDR Reset: 00 _H Monitor Mode Data Register	Bit Field				MN	İRR			
	Receive	Туре				r	h			
	Transmit	Bit Field				MN	ITR			
		Туре				١	V			
F6 _H	HWBPSR Reset: 00 _H Hardware Breakpoints Select Register	Bit Field		0		BPSEL _P		BPS	SEL	
		Туре		r		w		r	w	
F7 _H	HWBPDR Reset: 00 _H	Bit Field				HWE	3Pxx			
	Hardware Breakpoints Data Register					r	w			



3.3 Flash Memory

The Flash memory provides an embedded user-programmable non-volatile memory, allowing fast and reliable storage of user code and data. It is operated from a single 2.5 V supply from the Embedded Voltage Regulator (EVR) and does not require additional programming or erasing voltage. The sectorization of the Flash memory allows each sector to be erased independently.

Features

- · In-System Programming (ISP) via UART
- In-Application Programming (IAP)
- Error Correction Code (ECC) for dynamic correction of single-bit errors
- Background program and erase operations for CPU load minimization
- Support for aborting erase operation
- Minimum program width¹⁾ of 32-byte for D-Flash and 32-byte for P-Flash
- 1-sector minimum erase width
- 1-byte read access
- Flash is delivered in erased state (read all zeros)
- Operating supply voltage: 2.5 V ± 7.5 %
- Read access time: 3 x t_{CCLK} = 120 ns²⁾
- Program time: $209440 / f_{SYS} = 2.8 \text{ ms}^{3)}$
- Erase time: $8175360 / f_{SYS} = 109 \text{ ms}^{3)}$

Data Sheet 38 V1.1, 2012-12

P-Flash: 32-byte wordline can only be programmed once, i.e., one gate disturb allowed. D-Flash: 32-byte wordline can be programmed twice, i.e., two gate disturbs allowed.

 $f_{\rm SVS}$ = 75 MHz ± 7.5% ($f_{\rm CCLK}$ = 25 MHz ± 7.5 %) is the maximum frequency range for Flash read access.

³⁾ f_{sys} = 75 MHz ± 7.5% is the only frequency range for Flash programming and erasing. f_{sysmin} is used for obtaining the worst case timing.



Table 14 shows the Flash data retention and endurance targets.

Table 14 Flash Data Retention and Endurance

Retention	Endurance ¹⁾	Si	Size				
		T _A =- 40 to 125 °C	T _A = 125 to 150 °C				
Program Flas	sh		ı	ı.			
20 years	1,000 cycles	up to 16 Kbytes ²⁾		for 16-Kbyte Variant			
20 years	1,000 cycles	up to 8 Kbytes ²⁾		for 8-Kbyte Variant			
Data Flash	1	1					
20 years	1,000 cycles ³⁾	4 Kbytes	1 Kbytes				
5 years	10,000 cycles ³⁾	1 Kbyte	256 bytes				
2 years	70,000 cycles ³⁾	512 bytes	128 bytes				
2 years	100,000 cycles ³⁾	128 bytes	32 bytes				

One cycle refers to the programming of all wordlines in a sector and erasing of sector. The Flash endurance data specified in Table 14 is valid only if the following conditions are fulfilled:

⁻ the maximum number of erase cycles per Flash sector must not exceed 100,000 cycles.

⁻ the maximum number of erase cycles per Flash bank must not exceed 300,000 cycles.

⁻ the maximum number of program cycles per Flash bank must not exceed 2,500,000 cycles.

²⁾ If no Flash is used for data, the Program Flash size can be up to the maximum Flash size available in the device variant. Having more Data Flash will mean less Flash is available for Program Flash.

³⁾ For T_Δ=125 to 150°C, refers to programming of second 8 bytes (bytes 8 to 15) per WL



3.3.1 Flash Bank Sectorization

The SAL-XC866 product family offers four Flash devices with either 8 Kbytes or 16 Kbytes of embedded Flash memory. These Flash memory sizes are made up of two or four 4-Kbyte Flash banks, respectively. Each Flash device consists of Program Flash (P-Flash) bank(s) and a single Data Flash (D-Flash) bank with different sectorization shown in **Figure 10**. Both types can be used for code and data storage. The label "Data" neither implies that the D-Flash is mapped to the data memory region, nor that it can only be used for data storage. It is used to distinguish the different Flash bank sectorizations.

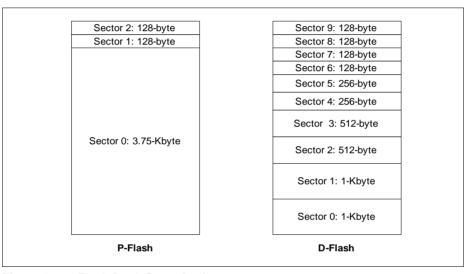


Figure 10 Flash Bank Sectorization

The internal structure of each Flash bank represents a sector architecture for flexible erase capability. The minimum erase width is always a complete sector, and sectors can be erased separately or in parallel. Contrary to standard EPROMs, erased Flash memory cells contain 0s.

The D-Flash bank is divided into more physical sectors for extended erasing and reprogramming capability; even numbers for each sector size are provided to allow greater flexibility and the ability to adapt to a wide range of application requirements.



3.3.2 Flash Programming Width

For the P-Flash banks, a programmed wordline (WL) must be erased before it can be reprogrammed as the Flash cells can only withstand one gate disturb. This means that the entire sector containing the WL must be erased since it is impossible to erase a single WL.

For the D-Flash bank, the same WL can be programmed twice before erasing is required as the Flash cells are able to withstand two gate disturbs. Hence, it is possible to program the same WL, for example, with 16 bytes of data in two times (see **Figure 11**).

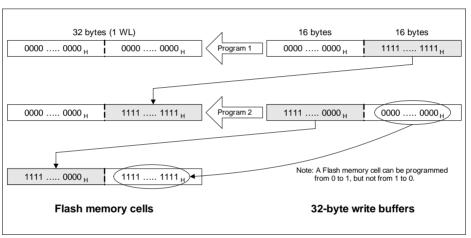


Figure 11 D-Flash Programming

Note: When programming a D-Flash WL the second time, the previously programmed Flash memory cells (whether 0s or 1s) should be reprogrammed with 0s to retain its original contents and to prevent "over-programming".

Data Sheet 41 V1.1, 2012-12



3.4 Interrupt System

The XC800 Core supports one non-maskable interrupt (NMI) and 14 maskable interrupt requests. In addition to the standard interrupt functions supported by the core, e.g., configurable interrupt priority and interrupt masking, the XC866 interrupt system provides extended interrupt support capabilities such as the mapping of each interrupt vector to several interrupt sources to increase the number of interrupt sources supported, and additional status registers for detecting and determining the interrupt source.

3.4.1 Interrupt Source

Figure 12 to Figure 16 give a general overview of the interrupt sources and illustrates the request and control flags.

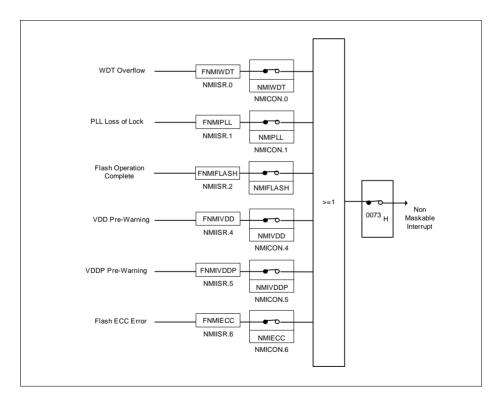


Figure 12 Non-Maskable Interrupt Request Sources



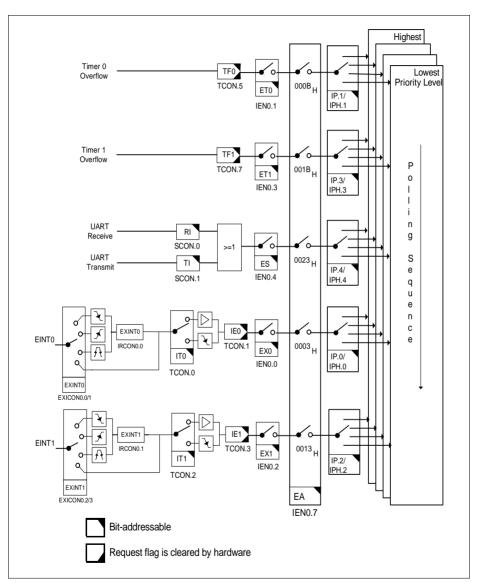


Figure 13 Interrupt Request Sources (Part 1)



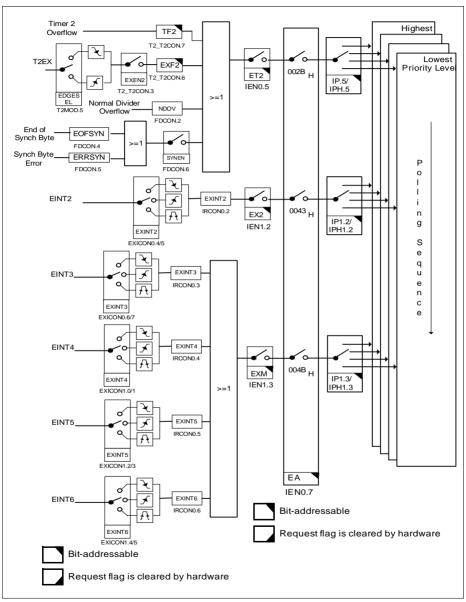


Figure 14 Interrupt Request Sources (Part 2)



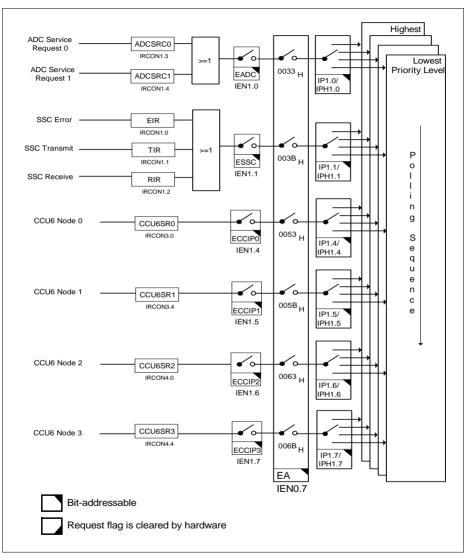


Figure 15 Interrupt Request Sources (Part 3)



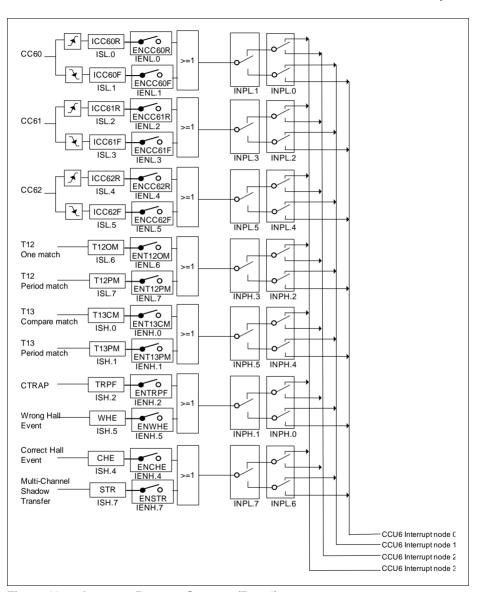


Figure 16 Interrupt Request Sources (Part 4)



3.4.2 Interrupt Source and Vector

Each interrupt source has an associated interrupt vector address. This vector is accessed to service the corresponding interrupt source request. The interrupt service of each interrupt source can be individually enabled or disabled via an enable bit. The assignment of the SAL-XC866 interrupt sources to the interrupt vector addresses and the corresponding interrupt source enable bits are summarized in **Table 15**.

Table 15 Interrupt Vector Addresses

Interrupt Source	Vector Address	Assignment for SAL- XC866	Enable Bit	SFR
NMI	0073 _H	Watchdog Timer NMI	NMIWDT	NMICON
		PLL NMI	NMIPLL	
		Flash NMI	NMIFLASH	
		VDDC Prewarning NMI	NMIVDD	
		VDDP Prewarning NMI	NMIVDDP	
		Flash ECC NMI	NMIECC	
XINTR0	0003 _H	External Interrupt 0	EX0	IEN0
XINTR1	000B _H	Timer 0	ET0	
XINTR2	0013 _H	External Interrupt 1	EX1	
XINTR3	001B _H	Timer 1	ET1	
XINTR4	0023 _H	UART	ES	
XINTR5	002B _H	T2	ET2	
		Fractional Divider (Normal Divider Overflow)		
		LIN		



Table 15 Interrupt Vector Addresses (cont'd)

XINTR6	0033 _H	ADC	EADC	IEN1
XINTR7	003B _H	SSC	ESSC	
XINTR8	0043 _H	External Interrupt 2	EX2	
XINTR9	004B _H	External Interrupt 3	EXM	
		External Interrupt 4		
		External Interrupt 5		
		External Interrupt 6		
XINTR10	0053 _H	CCU6 INP0	ECCIP0	
XINTR11	005B _H	CCU6 INP1	ECCIP1	
XINTR12	0063 _H	CCU6 INP2	ECCIP2	
XINTR13	006B _H	CCU6 INP3	ECCIP3	



3.4.3 Interrupt Priority

Each interrupt source, except for NMI, can be individually programmed to one of the four possible priority levels. The NMI has the highest priority and supersedes all other interrupts. Two pairs of interrupt priority registers (IP and IPH, IP1 and IPH1) are available to program the priority level of each non-NMI interrupt vector.

A low-priority interrupt can be interrupted by a high-priority interrupt, but not by another interrupt of the same or lower priority. Further, an interrupt of the highest priority cannot be interrupted by any other interrupt source.

If two or more requests of different priority levels are received simultaneously, the request of the highest priority is serviced first. If requests of the same priority are received simultaneously, then an internal polling sequence determines which request is serviced first. Thus, within each priority level, there is a second priority structure determined by the polling sequence shown in **Table 16**.

Table 16 Priority Structure within Interrupt Level

rable to Triotity ouractare within it					
Source	Level				
Non-Maskable Interrupt (NMI)	(highest)				
External Interrupt 0	1				
Timer 0 Interrupt	2				
External Interrupt 1	3				
Timer 1 Interrupt	4				
UART Interrupt	5				
Timer 2, Fractional Divider, LIN Interrupts	6				
ADC Interrupt	7				
SSC Interrupt	8				
External Interrupt 2	9				
External Interrupt [6:3]	10				
CCU6 Interrupt Node Pointer 0	11				
CCU6 Interrupt Node Pointer 1	12				
CCU6 Interrupt Node Pointer 2	13				
CCU6 Interrupt Node Pointer 3	14				



3.5 Parallel Ports

The SAL-XC866 has 27 port pins organized into four parallel ports, Port 0 (P0) to Port 3 (P3). Each pin has a pair of internal pull-up and pull-down devices that can be individually enabled or disabled. Ports P0, P1 and P3 are bidirectional and can be used as general purpose input/output (GPIO) or to perform alternate input/output functions for the on-chip peripherals. When configured as an output, the open drain mode can be selected. Port P2 is an input-only port, providing general purpose input functions, alternate input functions for the on-chip peripherals, and also analog inputs for the Analog-to-Digital Converter (ADC).

Bidirectional Port Features:

- Configurable pin direction
- Configurable pull-up/pull-down devices
- Configurable open drain mode
- Transfer of data through digital inputs and outputs (general purpose I/O)
- Alternate input/output for on-chip peripherals

Input Port Features:

- · Configurable input driver
- Configurable pull-up/pull-down devices
- Receive of data through digital input (general purpose input)
- Alternate input for on-chip peripherals
- · Analog input for ADC module



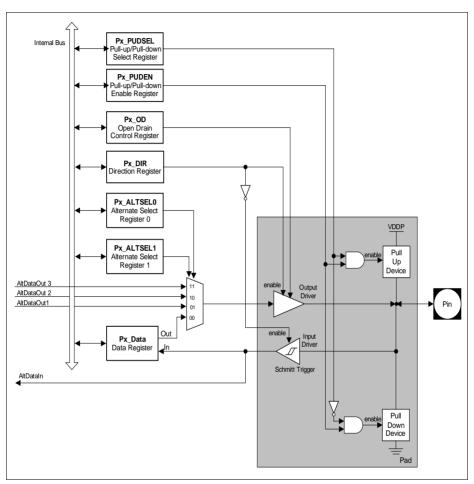


Figure 17 General Structure of Bidirectional Port



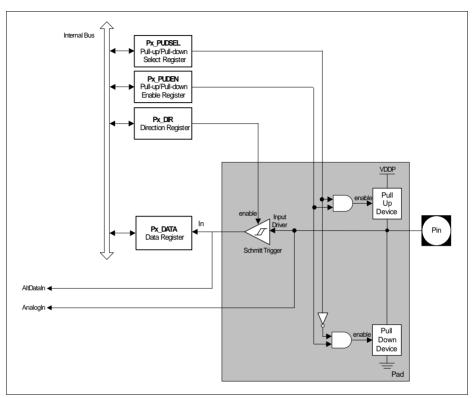


Figure 18 General Structure of Input Port



3.6 Power Supply System with Embedded Voltage Regulator

The SAL-XC866 microcontroller requires two different levels of power supply:

- 3.3 V or 5.0 V for the Embedded Voltage Regulator (EVR) and Ports
- 2.5 V for the core, memory, on-chip oscillator, and peripherals

Figure 19 shows the SAL-XC866 power supply system. A power supply of 3.3 V or 5.0 V must be provided from the external power supply pin. The 2.5 V power supply for the logic is generated by the EVR. The EVR helps to reduce the power consumption of the whole chip and the complexity of the application board design.

The EVR consists of a main voltage regulator and a low power voltage regulator. In active mode, both voltage regulators are enabled. In power-down mode, the main voltage regulator is switched off, while the low power voltage regulator continues to function and provide power supply to the system with low power consumption.

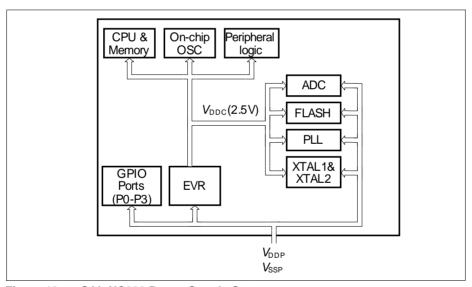


Figure 19 SAL-XC866 Power Supply System

EVR Features:

- Input voltage (V_{DDP}): 3.3 V/5.0 V
- Output voltage (V_{DDC}): 2.5 V ± 7.5%
- Low power voltage regulator provided in power-down mode
- V_{DDC} and V_{DDP} prewarning detection
- V_{DDC} brownout detection



3.7 Reset Control

The SAL-XC866 has five types of reset: power-on reset, hardware reset, watchdog timer reset, power-down wake-up reset, and brownout reset.

When the SAL-XC866 is first powered up, the status of certain pins (see **Table 18**) must be defined to ensure proper start operation of the device. At the end of a reset sequence, the sampled values are latched to select the desired boot option, which cannot be modified until the next power-on reset or hardware reset. This guarantees stable conditions during the normal operation of the device.

In order to power up the system properly, the external reset pin RESET must be asserted until $V_{\rm DDC}$ reaches $0.9^*V_{\rm DDC}$. The delay of external reset can be realized by an external capacitor at $\overline{\rm RESET}$ pin. This capacitor value must be selected so that $V_{\rm RESET}$ reaches 0.4 V, but not before $V_{\rm DDC}$ reaches 0.9* $V_{\rm DDC}$

A typical application example is shown in Figure 20. V_{DDP} capacitor value is 300 nF. V_{DDC} capacitor value is 220 nF. The capacitor connected to \overline{RESET} pin is 100 nF.

Typically, the time taken for $V_{\rm DDC}$ to reach $0.9^*V_{\rm DDC}$ is less than 50 μs once $V_{\rm DDP}$ reaches 2.3V. Hence, based on the condition that 10% to 90% $V_{\rm DDP}$ (slew rate) is less than 500 μs , the $\overline{\rm RESET}$ pin should be held low for 500 μs typically. See Figure 21.

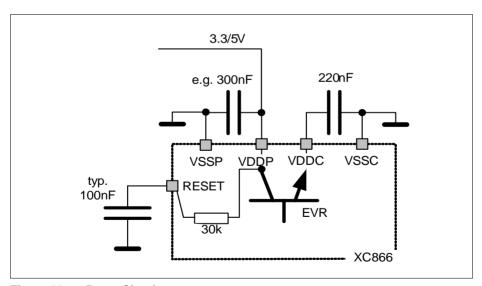


Figure 20 Reset Circuitry



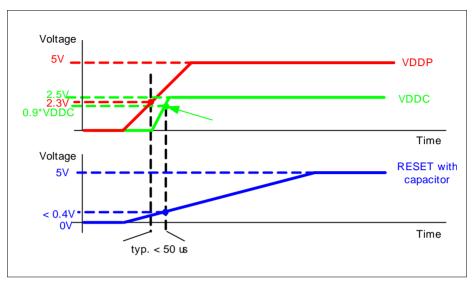


Figure 21 V_{DDP} , V_{DDC} and V_{RESET} during Power-on Reset

The second type of reset in SAL-XC866 is the hardware reset. This reset function can be used during normal operation or when the chip is in power-down mode. A reset input pin RESET is provided for the hardware reset. To ensure the recognition of the hardware reset, pin RESET must be held low for at least 100 ns.

The Watchdog Timer (WDT) module is also capable of resetting the device if it detects a malfunction in the system.

Another type of reset that needs to be detected is a reset while the device is in power-down mode (wake-up reset). While the contents of the static RAM are undefined after a power-on reset, they are well defined after a wake-up reset from power-down mode.



3.7.1 Module Reset Behavior

Table 17 shows how the functions of the SAL-XC866 are affected by the various reset types. A "■" means that this function is reset to its default state.

Table 17 Effect of Reset on Device Functions

Module/ Function	Wake-Up Reset	Watchdog Reset	Hardware Reset	Power-On Reset	Brownout Reset
CPU Core					
Peripherals					
On-Chip Static RAM	Not affected, reliable	Not affected, reliable	Not affected, reliable	Affected, un- reliable	Affected, un- reliable
Oscillator, PLL	-	Not affected			
Port Pins	-				
EVR	The voltage regulator is switched on	Not affected	-		
FLASH	-				
NMI	Disabled	Disabled			

3.7.2 Booting Scheme

When the SAL-XC866 is reset, it must identify the type of configuration with which to start the different modes once the reset sequence is complete. Thus, boot configuration information that is required for activation of special modes and conditions needs to be applied by the external world through input pins. After power-on reset or hardware reset, the pins MBC, TMS and P0.0 collectively select the different boot options. **Table 18** shows the available boot options in the SAL-XC866.

Table 18 SAL-XC866 Boot Selection

MBC	TMS	P0.0	Type of Mode	PC Start Value
1	0	х	User Mode; on-chip OSC/PLL non-bypassed	0000 _H
0	0	х	BSL Mode; on-chip OSC/PLL non-bypassed	0000 _H
0	1	0	OCDS Mode ¹⁾ ; on-chip OSC/PLL non- bypassed	0000 _H
1	1	0	Standalone User (JTAG) Mode ²⁾ ; on-chip OSC/PLL non-bypassed (normal)	0000 _H

¹⁾ The OCDS mode is not accessible if Flash is protected.

²⁾ Normal user mode with standard JTAG (TCK,TDI,TDO) pins for hot-attach purpose.



3.8 Clock Generation Unit

The Clock Generation Unit (CGU) allows great flexibility in the clock generation for the SAL-XC866. The power consumption is indirectly proportional to the frequency, whereas the performance of the microcontroller is directly proportional to the frequency. During user program execution, the frequency can be programmed for an optimal ratio between performance and power consumption. Therefore the power consumption can be adapted to the actual application state.

Features:

- Phase-Locked Loop (PLL) for multiplying clock source by different factors
- PLL Base Mode
- Prescaler Mode
- PLL Mode
- Power-down mode support

The CGU consists of an oscillator circuit and a PLL.In the SAL-XC866, the oscillator can be from either of these two sources: the on-chip oscillator (10 MHz) or the external oscillator (4 MHz to 12 MHz). The term "oscillator" is used to refer to both on-chip oscillator and external oscillator, unless otherwise stated. After the reset, the on-chip oscillator will be used by default. The external oscillator can be selected via software. In addition, the PLL provides a fail-safe logic to perform oscillator run and loss-of-lock detection. This allows emergency routines to be executed for system recovery or to perform system shut down.

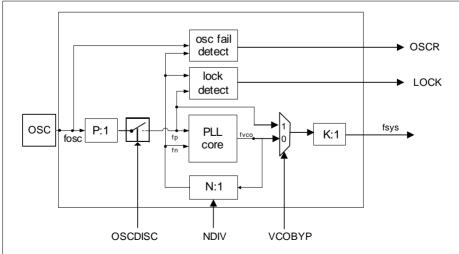


Figure 22 CGU Block Diagram



The clock system provides three ways to generate the system clock:

PLL Base Mode

The system clock is derived from the VCO base (free running) frequency clock divided by the K factor.

$$f_{SYS} = f_{VCObase} \times \frac{1}{K}$$

Prescaler Mode (VCO Bypass Operation)

In VCO bypass operation, the system clock is derived from the oscillator clock, divided by the P and K factors.

$$f_{SYS} = f_{OSC} \times \frac{1}{P \times K}$$

PLL Mode

The system clock is derived from the oscillator clock, multiplied by the N factor, and divided by the P and K factors. Both VCO bypass and PLL bypass must be inactive for this PLL mode. The PLL mode is used during normal system operation.

$$f_{SYS} = f_{OSC} \times \frac{N}{P \times K}$$

Table 19 shows the settings of bits OSCDISC and VCOBYP for different clock mode selection.

Table 19 Clock Mode Selection

OSCDISC	VCOBYP	Clock Working Modes
0	0	PLL Mode
0	1	Prescaler Mode
1	0	PLL Base Mode
1	1	PLL Base Mode

Note: When oscillator clock is disconnected from PLL, the clock mode is PLL Base mode regardless of the setting of VCOBYP bit.

System Frequency Selection

For the SAL-XC866, the values of P and K are fixed to "1" and "2", respectively. In order to obtain the required system frequency, f_{sys} , the value of N can be selected by bit NDIV for different oscillator inputs. **Table 20** provides examples on how $f_{sys} = 75$ MHz can be obtained for the different oscillator sources.



Table 20 System frequency (f_{svs} = 75 MHz)

Oscillator	f _{osc}	N	Р	K	f _{sys}
On-chip	10 MHz	15	1	2	75 MHz
External	10 MHz	15	1	2	75 MHz
	5 MHz	30	1	2	75 MHz

Table 21 shows the VCO range for the SAL-XC866.

Table 21 VCO Range

f _{VCOmin}	f _{VCOmax}	f _{VCOFREEmin}	f _{VCOFREEmax}	Unit
150	200	20	80	MHz
100	150	10	80	MHz

3.8.1 Recommended External Oscillator Circuits

The oscillator circuit, a Pierce oscillator, is designed to work with both, an external crystal oscillator or an external stable clock source. It basically consists of an inverting amplifier and a feedback element with XTAL1 as input, and XTAL2 as output.

When using a crystal, a proper external oscillator circuitry must be connected to both pins, XTAL1 and XTAL2. The crystal frequency can be within the range of 4 MHz to 12 MHz. Additionally, it is necessary to have two load capacitances $C_{\rm X1}$ and $C_{\rm X2}$, and depending on the crystal type, a series resistor $R_{\rm X2}$, to limit the current. A test resistor $R_{\rm Q}$ may be temporarily inserted to measure the oscillation allowance (negative resistance) of the oscillator circuitry. $R_{\rm Q}$ values are typically specified by the crystal vendor. The $C_{\rm X1}$ and $C_{\rm X2}$ values shown in Figure 23 can be used as starting points for the negative resistance evaluation and for non-productive systems. The exact values and related operating range are dependent on the crystal frequency and have to be determined and optimized together with the crystal vendor using the negative resistance method. Oscillation measurement with the final target system is strongly recommended to verify the input amplitude at XTAL1 and to determine the actual oscillation allowance (margin negative resistance) for the oscillator-crystal system.

When using an external clock signal, the signal must be connected to XTAL1. XTAL2 is left open (unconnected).

The oscillator can also be used in combination with a ceramic resonator. The final circuitry must also be verified by the resonator vendor.

Figure 23 shows the recommended external oscillator circuitries for both operating modes, external crystal mode and external input clock mode.



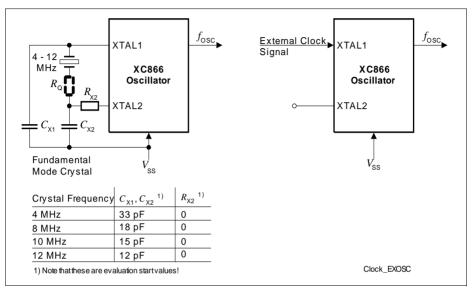


Figure 23 External Oscillator Circuitries

Note: For crystal operation, it is strongly recommended to measure the negative resistance in the final target system (layout) to determine the optimum parameters for the oscillator operation. Please refer to the minimum and maximum values of the negative resistance specified by the crystal supplier.



3.8.2 Clock Management

The CGU generates all clock signals required within the microcontroller from a single clock, f_{sys}. During normal system operation, the typical frequencies of the different modules are as follow:

- CPU clock: CCLK. SCLK = 25 MHz
- CCU6 clock: FCLK = 25 MHz
- Other peripherals: PCLK = 25 MHz
- Flash Interface clock: CCLK3 = 75 MHz and CCLK = 25 MHz

In addition, different clock frequency can output to pin CLKOUT(P0.0). The clock output frequency can further be divided by 2 using toggle latch (bit TLEN is set to 1), the resulting output frequency has 50% duty cycle. **Figure 24** shows the clock distribution of the SAL-XC866.

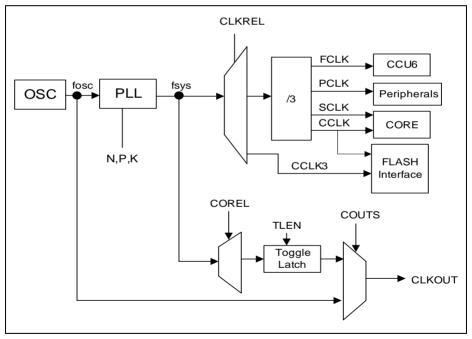


Figure 24 Clock Generation from f_{sys}



For power saving purposes, the clocks may be disabled or slowed down according to **Table 22**.

Table 22 System frequency (f_{sys} = 75 MHz)

Power Saving Mode	Action
Idle	Clock to the CPU is disabled.
Slow-down	Clocks to the CPU and all the peripherals, including CCU6, are divided by a common programmable factor defined by bit field CMCON.CLKREL.
Power-down	Oscillator and PLL are switched off.



3.9 Power Saving Modes

The power saving modes of the SAL-XC866 provide flexible power consumption through a combination of techniques, including:

- Stopping the CPU clock
- · Stopping the clocks of individual system components
- · Reducing clock speed of some peripheral components
- Power-down of the entire system with fast restart capability

After a reset, the active mode (normal operating mode) is selected by default (see Figure 25) and the system runs in the main system clock frequency. From active mode, different power saving modes can be selected by software. They are:

- Idle mode
- Slow-down mode
- Power-down mode

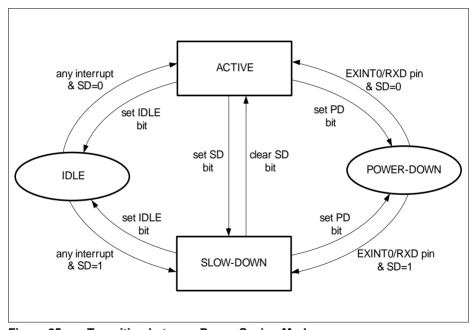


Figure 25 Transition between Power Saving Modes



3.10 Watchdog Timer

The Watchdog Timer (WDT) provides a highly reliable and secure way to detect and recover from software or hardware failures. The WDT is reset at a regular interval that is predefined by the user. The CPU must service the WDT within this interval to prevent the WDT from causing an SAL-XC866 system reset. Hence, routine service of the WDT confirms that the system is functioning properly. This ensures that an accidental malfunction of the SAL-XC866 will be aborted in a user-specified time period. In debug mode, the WDT is suspended and stops counting. Therefore, there is no need to refresh the WDT during debugging.

Features:

- 16-bit Watchdog Timer
- Programmable reload value for upper 8 bits of timer
- Programmable window boundary
- Selectable input frequency of f_{PCLK}/2 or f_{PCLK}/128
- Time-out detection with NMI generation and reset prewarning activation (after which a system reset will be performed)

The WDT is a 16-bit timer incremented by a count rate of $f_{PCLK}/2$ or $f_{PCLK}/128$. This 16-bit timer is realized as two concatenated 8-bit timers. The upper 8 bits of the WDT can be preset to a user-programmable value via a watchdog service access in order to modify the watchdog expire time period. The lower 8 bits are reset on each service access. **Figure 26** shows the block diagram of the WDT unit.

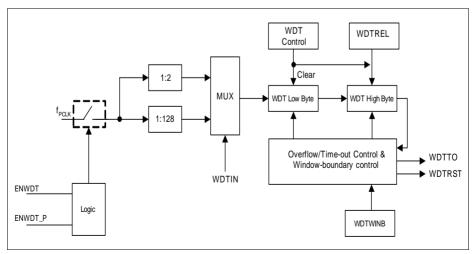


Figure 26 WDT Block Diagram



If the WDT is not serviced before the timer overflow, a system malfunction is assumed. As a result, the WDT NMI is triggered (assert WDTTO) and the reset prewarning is entered. The prewarning period lasts for $30_{\rm H}$ count, after which the system is reset (assert WDTRST).

The WDT has a "programmable window boundary" which disallows any refresh during the WDT's count-up. A refresh during this window boundary constitutes an invalid access to the WDT, causing the reset prewarning to be entered but without triggering the WDT NMI. The system will still be reset after the prewarning period is over. The window boundary is from $0000_{\rm H}$ to the value obtained from the concatenation of WDTWINB and $00_{\rm H}$.

After being serviced, the WDT continues counting up from the value (<WDTREL> * 2⁸). The time period for an overflow of the WDT is programmable in two ways:

- the input frequency to the WDT can be selected to be either f_{PCLK}/2 or f_{PCLK}/128
- the reload value WDTREL for the high byte of WDT can be programmed in register WDTRFI

The period, P_{WDT} , between servicing the WDT and the next overflow can be determined by the following formula:

$$P_{WDT} = \frac{2^{(1+WDTIN\times6)} \times (2^{16} - WDTREL \times 2^{8})}{f_{PCLK}}$$

If the Window-Boundary Refresh feature of the WDT is enabled, the period P_{WDT} between servicing the WDT and the next overflow is shortened if WDTWINB is greater than WDTREL, see **Figure 27**. This period can be calculated using the same formula by replacing WDTREL with WDTWINB. For this feature to be useful, WDTWINB should not be smaller than WDTREL.

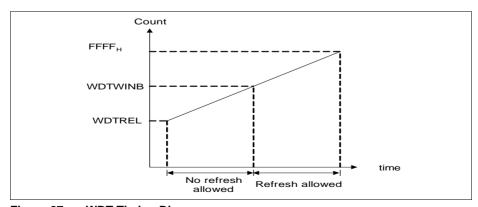


Figure 27 WDT Timing Diagram



Table 23 lists the possible watchdog time range that can be achieved for different module clock frequencies. Some numbers are rounded to 3 significant digits.

Table 23 Watchdog Time Ranges

Reload value in WDTREL	Prescaler for f _{PCLK}			
	2 (WDTIN = 0)	128 (WDTIN = 1)		
	25 MHz	25 MHz		
FF _H	20.5 μs	1.31 ms		
7F _H	2.64 ms	169 ms		
00 _H	5.24 ms	336 ms		



3.11 Universal Asynchronous Receiver/Transmitter

The Universal Asynchronous Receiver/Transmitter (UART) provides a full-duplex asynchronous receiver/transmitter, i.e., it can transmit and receive simultaneously. It is also receive-buffered, i.e., it can commence reception of a second byte before a previously received byte has been read from the receive register. However, if the first byte still has not been read by the time reception of the second byte is complete, one of the bytes will be lost.

Features:

- · Full-duplex asynchronous modes
 - 8-bit or 9-bit data frames, LSB first
 - fixed or variable baud rate
- · Receive buffered
- Multiprocessor communication
- Interrupt generation on the completion of a data transmission or reception

The UART can operate in four asynchronous modes as shown in **Table 24**. Data is transmitted on TXD and received on RXD.

Table 24 UART Modes

Operating Mode	Baud Rate
Mode 0: 8-bit shift register	f _{PCLK} /2
Mode 1: 8-bit shift UART	Variable
Mode 2: 9-bit shift UART	f _{PCLK} /32 or f _{PCLK} /64
Mode 3: 9-bit shift UART	Variable

There are several ways to generate the baud rate clock for the serial port, depending on the mode in which it is operating. In mode 0, the baud rate for the transfer is fixed at $f_{PCLK}/2$. In mode 2, the baud rate is generated internally based on the UART input clock and can be configured to either $f_{PCLK}/32$ or $f_{PCLK}/64$. The variable baud rate is set by either the underflow rate on the dedicated baud-rate generator, or by the overflow rate on Timer 1.



3.11.1 Baud-Rate Generator

The baud-rate generator is based on a programmable 8-bit reload value, and includes divider stages (i.e., prescaler and fractional divider) for generating a wide range of baud rates based on its input clock f_{PCLK}, see **Figure 28**.

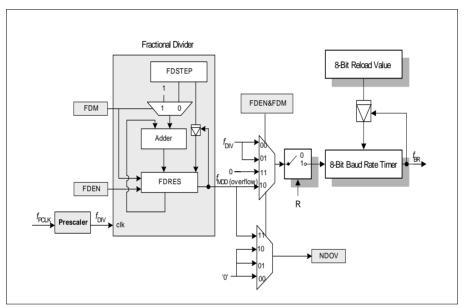


Figure 28 Baud-rate Generator Circuitry

The baud rate timer is a count-down timer and is clocked by either the output of the fractional divider (f_{MOD}) if the fractional divider is enabled (FDCON.FDEN = 1), or the output of the prescaler (f_{DIV}) if the fractional divider is disabled (FDEN = 0). For baud rate generation, the fractional divider must be configured to fractional divider mode (FDCON.FDM = 0). This allows the baud rate control run bit BCON.R to be used to start or stop the baud rate timer. At each timer underflow, the timer is reloaded with the 8-bit reload value in register BG and one clock pulse is generated for the serial channel.

Enabling the fractional divider in normal divider mode (FDEN = 1 and FDM = 1) stops the baud rate timer and nullifies the effect of bit BCON.R. See **Section 3.12**.

The baud rate (f_{BR}) value is dependent on the following parameters:

- Input clock f_{PCLK}
- Prescaling factor (2^{BRPRE}) defined by bit field BRPRE in register BCON
- Fractional divider (STEP/256) defined by register FDSTEP (to be considered only if fractional divider is enabled and operating in fractional divider mode)



• 8-bit reload value (BR_VALUE) for the baud rate timer defined by register BG The following formulas calculate the final baud rate without and with the fractional divider respectively:

baud rate =
$$\frac{f_{PCLK}}{16 \times 2^{BRPRE} \times (BR_VALUE + 1)}$$
 where $2^{BRPRE} \times (BR_VALUE + 1) > 1$

$$\text{baud rate } = \frac{f_{PCLK}}{16 \times 2^{BRPRE} \times (BR_VALUE + 1)} \times \frac{STEP}{256}$$

The maximum baud rate that can be generated is limited to f_{PCLK}/32. Hence, for a module clock of 25 MHz, the maximum achievable baud rate is 0.78 MBaud.

Standard LIN protocol can support a maximum baud rate of 20kHz, the baud rate accuracy is not critical and the fractional divider can be disabled. Only the prescaler is used for auto baud rate calculation. For LIN fast mode, which supports the baud rate of 20kHz to 115.2kHz, the higher baud rates require the use of the fractional divider for greater accuracy.

Table 25 lists the various commonly used baud rates with their corresponding parameter settings and deviation errors. The fractional divider is disabled and a module clock of 25 MHz is used.

Table 25 Typical Baud rates for UART with Fractional Divider disabled

Baud rate	Prescaling Factor (2 ^{BRPRE})	Reload Value (BR_VALUE + 1)	Deviation Error
19.2 kBaud	1 (BRPRE=000 _B)	81 (51 _H)	-0.47 %
9600 Baud	1 (BRPRE=000 _B)	162 (A2 _H)	-0.47 %
4800 Baud	2 (BRPRE=001 _B)	162 (A2 _H)	-0.47 %
2400 Baud	4 (BRPRE=010 _B)	162 (A2 _H)	-0.47 %

The fractional divider allows baud rates of higher accuracy (lower deviation error) to be generated. **Table 26** lists the resulting deviation errors from generating a baud rate of 115.2 kHz, using different module clock frequencies. The fractional divider is enabled (fractional divider mode) and the corresponding parameter settings are shown.

Data Sheet 69 V1.1, 2012-12



Table 26 Deviation Error for UART with Fractional Divider enabled

f _{PCLK}	Prescaling Factor (2 ^{BRPRE})	Reload Value (BR_VALUE + 1)	STEP	Deviation Error
25 MHz	1	10 (A _H)	189 (BD _H)	+0.14 %
12.5 MHz	1	6 (6 _H)	226 (E2 _H)	-0.22 %
6.25 MHz	1	3 (3 _H)	226 (E2 _H)	-0.22 %



3.11.2 Baud Rate Generation using Timer 1

In UART modes 1 and 3, Timer 1 can be used for generating the variable baud rates. In theory, this timer could be used in any of its modes. But in practice, it should be set into auto-reload mode (Timer 1 mode 2), with its high byte set to the appropriate value for the required baud rate. The baud rate is determined by the Timer 1 overflow rate and the value of SMOD as follows:

Mode 1, 3 baud rate=
$$\frac{2^{\text{SMOD}} \times f_{\text{PCLK}}}{32 \times 2 \times (256 - \text{TH1})}$$
 [3.1]

3.12 Normal Divider Mode (8-bit Auto-reload Timer)

Setting bit FDM in register FDCON to 1 configures the fractional divider to normal divider mode, while at the same time disables baud rate generation (see **Figure 28**). Once the fractional divider is enabled (FDEN = 1), it functions as an 8-bit auto-reload timer (with no relation to baud rate generation) and counts up from the reload value with each input clock pulse. Bit field RESULT in register FDRES represents the timer value, while bit field STEP in register FDSTEP defines the reload value. At each timer overflow, an overflow flag (FDCON.NDOV) will be set and an interrupt request generated. This gives an output clock f_{MOD} that is 1/n of the input clock f_{DIV} , where n is defined by 256 - STEP.

The output frequency in normal divider mode is derived as follows:

$$f_{\text{MOD}} = f_{\text{DIV}} \times \frac{1}{256 - \text{STEP}}$$
 [3.2]

Data Sheet 71 V1.1, 2012-12



3.13 LIN Protocol

The UART can be used to support the Local Interconnect Network (LIN) protocol for both master and slave operations. The LIN baud rate detection feature provides the capability to detect the baud rate within LIN protocol using Timer 2. This allows the UART to be synchronized to the LIN baud rate for data transmission and reception.

LIN is a holistic communication concept for local interconnected networks in vehicles. The communication is based on the SCI (UART) data format, a single-master/multiple-slave concept, a clock synchronization for nodes without stabilized time base. An attractive feature of LIN is self-synchronization of the slave nodes without a crystal or ceramic resonator, which significantly reduces the cost of hardware platform. Hence, the baud rate must be calculated and returned with every message frame.

The structure of a LIN frame is shown in Figure 29. The frame consists of the:

- header, which comprises a Break (13-bit time low), Synch Byte (55_H), and ID field
- · response time
- data bytes (according to UART protocol)
- checksum

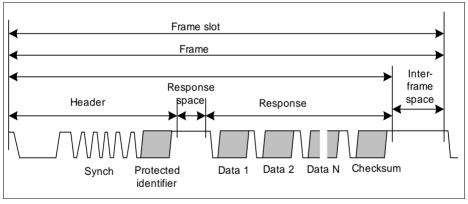


Figure 29 Structure of LIN Frame

3.13.1 LIN Header Transmission

LIN header transmission is only applicable in master mode. In the LIN communication, a master task decides when and which frame is to be transferred on the bus. It also identifies a slave task to provide the data transported by each frame. The information needed for the handshaking between the master and slave tasks is provided by the master task through the header portion of the frame.

The header consists of a break and synch pattern followed by an identifier. Among these three fields, only the break pattern cannot be transmitted as a normal 8-bit UART data.



The break must contain a dominant value of 13 bits or more to ensure proper synchronization of slave nodes.

In the LIN communication, a slave task is required to be synchronized at the beginning of the protected identifier field of frame. For this purpose, every frame starts with a sequence consisting of a break field followed by a synch byte field. This sequence is unique and provides enough information for any slave task to detect the beginning of a new frame and be synchronized at the start of the identifier field.

Upon entering LIN communication, a connection is established and the transfer speed (baud rate) of the serial communication partner (host) is automatically synchronized in the following steps:

STEP 1: Initialize interface for reception and timer for baud rate measurement

STEP 2: Wait for an incoming LIN frame from host

STEP 3: Synchronize the baud rate to the host

STEP 4: Enter for Master Request Frame or for Slave Response Frame

Note: Re-synchronization and setup of baud rate are always done for **every** Master Request Header or Slave Response Header LIN frame.



3.14 High-Speed Synchronous Serial Interface

The High-Speed Synchronous Serial Interface (SSC) supports full-duplex and half-duplex synchronous communication. The serial clock signal can be generated by the SSC internally (master mode), using its own 16-bit baud-rate generator, or can be received from an external master (slave mode). Data width, shift direction, clock polarity and phase are programmable. This allows communication with SPI-compatible devices or devices using other synchronous serial interfaces.

Features:

- · Master and slave mode operation
 - Full-duplex or half-duplex operation
- · Transmit and receive buffered
- Flexible data format
 - Programmable number of data bits: 2 to 8 bits
 - Programmable shift direction: LSB or MSB shift first
 - Programmable clock polarity: idle low or high state for the shift clock
 - Programmable clock/data phase: data shift with leading or trailing edge of the shift clock
- Variable baud rate
- Compatible with Serial Peripheral Interface (SPI)
- · Interrupt generation
 - On a transmitter empty condition
 - On a receiver full condition
 - On an error condition (receive, phase, baud rate, transmit error)



Data is transmitted or received on lines TXD and RXD, which are normally connected to the pins MTSR (Master Transmit/Slave Receive) and MRST (Master Receive/Slave Transmit). The clock signal is output via line MS_CLK (Master Serial Shift Clock) or input via line SS_CLK (Slave Serial Shift Clock). Both lines are normally connected to the pin SCLK. Transmission and reception of data are double-buffered.

Figure 30 shows the block diagram of the SSC.

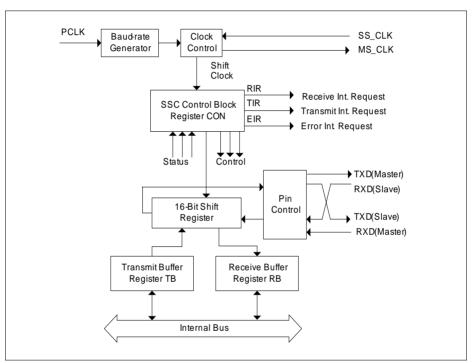


Figure 30 SSC Block Diagram



3.15 Timer 0 and Timer 1

Timers 0 and 1 are count-up timers which are incremented every machine cycle, or in terms of the input clock, every 2 PCLK cycles. They are fully compatible and can be configured in four different operating modes for use in a variety of applications, see **Table 27**. In modes 0, 1 and 2, the two timers operate independently, but in mode 3, their functions are specialized.

Table 27 Timer 0 and Timer 1 Modes

Mode	Operation
0	13-bit timer The timer is essentially an 8-bit counter with a divide-by-32 prescaler. This mode is included solely for compatibility with Intel 8048 devices.
1	16-bit timer The timer registers, TLx and THx, are concatenated to form a 16-bit counter.
2	8-bit timer with auto-reload The timer register TLx is reloaded with a user-defined 8-bit value in THx upon overflow.
3	Timer 0 operates as two 8-bit timers The timer registers, TL0 and TH0, operate as two separate 8-bit counters. Timer 1 is halted and retains its count even if enabled.



3.16 Timer 2

Timer 2 is a 16-bit general purpose timer (THL2) that has two modes of operation, a 16-bit auto-reload mode and a 16-bit one channel capture mode. If the prescalar is disabled, Timer 2 counts with an input clock of PCLK/12. Timer 2 continues counting as long as it is enabled.

Table 28	Timer 2 Modes
Mode	Description
Auto-reload	Up/Down Count Disabled Count up only Start counting from 16-bit reload value, overflow at FFFF _H Reload event configurable for trigger by overflow condition only, or by negative/positive edge at input pin T2EX as well Programmble reload value in register RC2 Interrupt is generated with reload event
	 Up/Down Count Enabled Count up or down, direction determined by level at input pin T2EX No interrupt is generated Count up Start counting from 16-bit reload value, overflow at FFFFH Reload event triggered by overflow condition Programmble reload value in register RC2 Count down Start counting from FFFFH, underflow at value defined in register RC2 Reload event triggered by underflow condition Reload value fixed at FFFFH
Channel capture	 Count up only Start counting from 0000_H, overflow at FFFF_H Reload event triggered by overflow condition Reload value fixed at 0000_H Capture event triggered by falling/rising edge at pin T2EX Captured timer value stored in register RC2 Interrupt is generated with reload or capture event



3.17 Capture/Compare Unit 6

The Capture/Compare Unit 6 (CCU6) provides two independent timers (T12, T13), which can be used for Pulse Width Modulation (PWM) generation, especially for AC-motor control. The CCU6 also supports special control modes for block commutation and multi-phase machines.

The timer T12 can function in capture and/or compare mode for its three channels. The timer T13 can work in compare mode only.

The multi-channel control unit generates output patterns, which can be modulated by T12 and/or T13. The modulation sources can be selected and combined for the signal modulation.

Timer T12 Features:

- Three capture/compare channels, each channel can be used either as a capture or as a compare channel
- Supports generation of a three-phase PWM (six outputs, individual signals for highside and lowside switches)
- 16-bit resolution, maximum count frequency = peripheral clock frequency
- · Dead-time control for each channel to avoid short-circuits in the power stage
- Concurrent update of the required T12/13 registers
- Generation of center-aligned and edge-aligned PWM
- Supports single-shot mode
- Supports many interrupt request sources
- · Hysteresis-like control mode

Timer T13 Features:

- · One independent compare channel with one output
- 16-bit resolution, maximum count frequency = peripheral clock frequency
- Can be synchronized to T12
- Interrupt generation at period-match and compare-match
- Supports single-shot mode

Additional Features:

- Implements block commutation for Brushless DC-drives
- Position detection via Hall-sensor pattern
- Automatic rotational speed measurement for block commutation
- Integrated error handling
- Fast emergency stop without CPU load via external signal (CTRAP)
- · Control modes for multi-channel AC-drives
- Output levels can be selected and adapted to the power stage



The block diagram of the CCU6 module is shown in Figure 31.

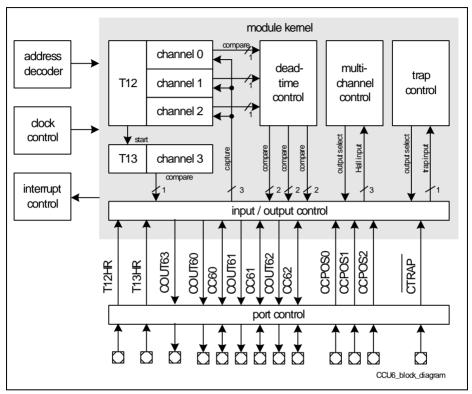


Figure 31 CCU6 Block Diagram



3.18 Analog-to-Digital Converter

The SAL-XC866 includes a high-performance 10-bit Analog-to-Digital Converter (ADC) with eight multiplexed analog input channels. The ADC uses a successive approximation technique to convert the analog voltage levels from up to eight different sources. The analog input channels of the ADC are available at Port 2.

Features:

- · Successive approximation
- · 8-bit or 10-bit resolution
- · Eight analog channels
- · Four independent result registers
- Result data protection for slow CPU access (wait-for-read mode)
- · Single conversion mode
- · Autoscan functionality
- · Limit checking for conversion results
- Data reduction filter (accumulation of up to 2 conversion results)
- Two independent conversion request sources with programmable priority
- Selectable conversion request trigger
- · Flexible interrupt generation with configurable service nodes
- · Programmable sample time
- · Programmable clock divider
- · Cancel/restart feature for running conversions
- Integrated sample and hold circuitry
- Compensation of offset errors
- · Low power modes



3.18.1 ADC Clocking Scheme

A common module clock $f_{\mbox{ADC}}$ generates the various clock signals used by the analog and digital parts of the ADC module:

- f_{ADCA} is input clock for the analog part.
- f_{ADCI} is internal clock for the analog part (defines the time base for conversion length and the sample time). This clock is generated internally in the analog part, based on the input clock f_{ADCA} to generate a correct duty cycle for the analog components.
- f_{ADCD} is input clock for the digital part.

The internal clock for the analog part f_{ADCI} is limited to a maximum frequency of 10 MHz. Therefore, the ADC clock prescaler must be programmed to a value that ensures f_{ADCI} does not exceed 10 MHz. The prescaler ratio is selected by bit field CTC in register GLOBCTR. A prescaling ratio of 32 can be selected when the maximum performance of the ADC is not required.

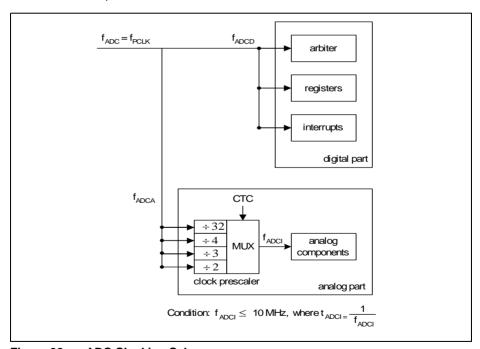


Figure 32 ADC Clocking Scheme



For module clock f_{ADC} = 25 MHz, the analog clock f_{ADCI} frequency can be selected as shown in **Table 29**.

Table 29 f_{ADCI} Frequency Selection

Module Clock f _{ADC}	СТС	Prescaling Ratio	Analog Clock f _{ADCI}
25 MHz	00 _B	÷ 2	12.5 MHz (N.A)
	01 _B	÷ 3	8.3 MHz
	10 _B	÷ 4	6.3 MHz
	11 _B (default)	÷ 32	781.3 kHz

As f_{ADCI} cannot exceed 10 MHz, bit field CTC should not be set to 00_B when f_{ADC} is 25 MHz. During slow-down mode where f_{ADC} may be reduced to 12.5 MHz, 6.25 MHz etc., CTC can be set to 00_B as long as the divided analog clock f_{ADCI} does not exceed 10 MHz. However, it is important to note that the conversion error could increase due to loss of charges on the capacitors, if f_{ADC} becomes too low during slow-down mode.

3.18.2 ADC Conversion Sequence

The analog-to-digital conversion procedure consists of the following phases:

- Synchronization phase (t_{SYN})
- Sample phase (t_S)
- · Conversion phase
- Write result phase (t_{WR})

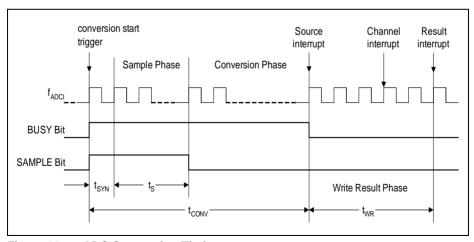


Figure 33 ADC Conversion Timing



3.19 On-Chip Debug Support

The On-Chip Debug Support (OCDS) provides the basic functionality required for the software development and debugging of XC800-based systems.

The OCDS design is based on these principles:

- use the built-in debug functionality of the XC800 Core
- · add a minimum of hardware overhead
- provide support for most of the operations by a Monitor Program
- use standard interfaces to communicate with the Host (a Debugger)

Features:

- · Set breakpoints on instruction address and within a specified address range
- · Set breakpoints on internal RAM address
- Support unlimited software breakpoints in Flash/RAM code region
- Process external breaks
- · Step through the program code

The OCDS functional blocks are shown in **Figure 34**. The Monitor Mode Control (MMC) block at the center of OCDS system brings together control signals and supports the overall functionality. The MMC communicates with the XC800 Core, primarily via the Debug Interface, and also receives reset and clock signals. After processing memory address and control signals from the core, the MMC provides proper access to the dedicated extra-memories: a Monitor ROM (holding the code) and a Monitor RAM (for work-data and Monitor-stack). The OCDS system is accessed through the JTAG¹⁾, which is an interface dedicated exclusively for testing and debugging activities and is not normally used in an application. The dedicated MBC pin is used for external configuration and debugging control.

Note: All the debug functionality described here can normally be used only after SAL-XC866 has been started in OCDS mode.

Data Sheet 83 V1.1, 2012-12

¹⁾ The pins of the JTAG port can be assigned to either Port 0 (primary) or Ports 1 and 2 (secondary). User must set the JTAG pins (TCK and TDI) as input during connection with the OCDS system.



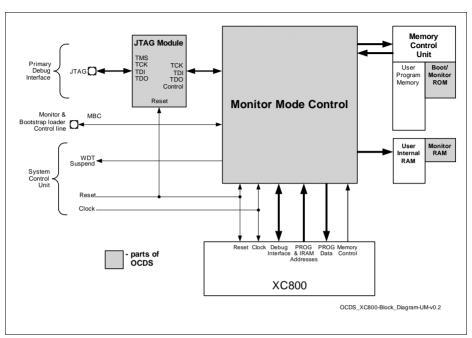


Figure 34 OCDS Block Diagram

3.19.1 JTAG ID Register

This is a read-only register located inside the JTAG module, and is used to recognize the device(s) connected to the JTAG interface. Its content is shifted out when INSTRUCTION register contains the IDCODE command (opcode $04_{\rm H}$), and the same is also true immediately after reset.

The JTAG ID register contents for the SAL-XC866 devices are given in Table 30.

Table 30 JTAG ID Summary

Device Type	Device Name	JTAG ID
Flash	SAL-XC866L-4FRA	1010 0083 _H
	SAL-XC866L-2FRA	1010 2083 _H



3.20 Identification Register

The SAL-XC866 identity register is located at Page 1 of address B3_H.

ID

Identity Register Reset Value: 0000 0010_B



Field	Bits	Туре	Description
VERID	[2:0]	r	Version ID 010 _B
PRODID	[7:3]	r	Product ID 00000 _B



4 Electrical Parameters

Chapter 4 provides the characteristics of the electrical parameters which are implementation-specific for the SAL-XC866.

4.1 General Parameters

The general parameters are described here to aid the users in interpreting the parameters mainly in **Section 4.2** and **Section 4.3**.

4.1.1 Parameter Interpretation

The parameters listed in this section represent partly the characteristics of the SAL-XC866 and partly its requirements on the system. To aid interpreting the parameters easily when evaluating them for a design, they are indicated by the abbreviations in the "Symbol" column:

• CC

These parameters indicate **C**ontroller **C**haracteristics, which are distinctive features of the SAL-XC866 and must be regarded for a system design.

SR

These parameters indicate **S**ystem **R**equirements, which must be provided by the microcontroller system in which the SAL-XC866 is designed in.



4.1.2 Absolute Maximum Rating

Maximum ratings are the extreme limits to which the SAL-XC866 can be subjected to without permanent damage.

Table 31 Absolute Maximum Rating Parameters

Parameter	Symbol	Lim	it Values	Unit	Notes	
		min.	max.			
Ambient temperature	T_{A}	-40	150	°C	under bias	
Storage temperature	T_{ST}	-65	150	°C	1)	
Junction temperature	T_{J}	-40	160	°C	under bias ¹⁾	
Voltage on power supply pin with respect to $V_{\rm SS}$	V_{DDP}	-0.5	6	V	1)	
Voltage on any pin with respect to $V_{\rm SS}$	V_{IN}	-0.5	V _{DDP} + 0.5 or max. 6	V	Whichever is lower ¹⁾	
Input current on any pin during overload condition	I _{IN}	-10	10	mA	1)	
Absolute sum of all input currents during overload condition	$\Sigma I_{IN} $	_	50	mA	1)	

¹⁾ Not subjected to production test, verified by design/characterization.

Note: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. During absolute maximum rating overload conditions ($V_{\rm IN} > V_{\rm DDP}$ or $V_{\rm IN} < V_{\rm SS}$) the voltage on $V_{\rm DDP}$ pin with respect to ground ($V_{\rm SS}$) must not exceed the values defined by the absolute maximum ratings.



4.1.3 Operating Conditions

The following operating conditions must not be exceeded in order to ensure correct operation of the SAL-XC866. All parameters mentioned in the following table refer to these operating conditions, unless otherwise noted.

Table 32 Operating Condition Parameters

Parameter	Symbol	Limit Values		Unit	Notes/	
		min.	max.		Conditions	
Digital power supply voltage	V_{DDP}	4.5	5.5	V	5V Device	
Digital power supply voltage	V_{DDP}	3.0	3.6	V	3.3V Device	
Digital ground voltage	V_{SS}		0	V		
Digital core supply voltage	V_{DDC}	2.3	2.7	V		
System Clock Frequency ¹⁾	$f_{\sf SYS}$	69	81	MHz		
Ambient temperature	T_{A}	-40	150	°C	SAL-XC866	

¹⁾ f_{SYS} is the PLL output clock. During normal operating mode, CPU clock is f_{SYS} / 3. Please refer to Figure 24 for detailed description.



4.2 DC Parameters

4.2.1 Input/Output Characteristics

Table 33 Input/Output Characteristics (Operating Conditions apply)

Parameter	Symbol	Limit	Values	Unit	Test Conditions	
		min.	max.			
V _{DDP} = 5V Range			•	•		
Output low voltage	V_{OL} CC	_	1.0	V	I _{OL} = 15 mA	
		_	0.4	V	$I_{\rm OL}$ = 5 mA	
Output high voltage	V _{OH} CC	V _{DDP} - 1.0	_	V	I _{OH} = -15 mA	
		V _{DDP} - 0.4	_	V	I _{OH} = -5 mA	
Input low voltage on port pins (all except P0.0 & P0.1)	V _{ILP} SR	-	$0.3 \times V_{DDP}$	V	CMOS Mode	
Input low voltage on P0.0 & P0.1	$V_{\rm ILP0}$ SR	-0.2	$0.3 imes V_{DDP}$	V	CMOS Mode	
Input low voltage on RESET pin	V_{ILR} SR	_	$0.3 imes V_{DDP}$	V	CMOS Mode	
Input low voltage on TMS pin	V_{ILT} SR	-	$0.3 imes V_{DDP}$	V	CMOS Mode	
Input high voltage on port pins (all except P0.0 & P0.1)	V _{IHP} SR	$0.7 imes V_{DDP}$	_	V	CMOS Mode	
Input high voltage on P0.0 & P0.1	$V_{IHP0}SR$	$0.7 imes V_{DDP}$	V_{DDP}	V	CMOS Mode	
Input high voltage on RESET pin	V_{IHR} SR	$0.7 imes V_{DDP}$	_	V	CMOS Mode	
Input high voltage on TMS pin	V_{IHT} SR	$0.75 imes V_{DDP}$	_	V	CMOS Mode	
Input Hysteresis ¹⁾ on Port Pins	HYS CC	$0.08 imes V_{ m DDP}$	_	V	CMOS Mode	
Input Hysteresis ¹⁾ on XTAL1	HYSXCC	$V_{ m DDC}$	_	V		



Table 33 Input/Output Characteristics (Operating Conditions apply)

Parameter	Symbol		Limit Values		Unit	Test Conditions
			min.	max.		
Input low voltage at XTAL1	V_{ILX}	SR	V _{SS} - 0.5	$0.3 imes V_{ m DDC}$	V	
Input high voltage at XTAL1	V_{IHX}	SR	$0.7 imes V_{ m DDC}$	V _{DDC} + 0.5	V	
Pull-up current	I_{PU}	SR	_	-10	μΑ	$V_{IH,min}$
			-150	_	μΑ	$V_{IL,max}$
Pull-down current	I_{PD}	SR	-	10	μΑ	$V_{IL,max}$
			150	_	μΑ	$V_{IH,min}$
Input leakage current ²⁾	I _{OZ1}	CC	-2	2	μΑ	$0 < V_{\text{IN}} < V_{\text{DDP}},$ $T_{\text{A}} \le 150^{\circ}\text{C}$
Input current at XTAL1	I_{ILX}	CC	-10	10	μΑ	
Overload current on any pin	I_{OV}	SR	-5	5	mA	3)
Absolute sum of overload currents	$\Sigma I_{OV} $	SR	_	25	mA	3)
Voltage on any pin during V_{DDP} power off	V_{PO}	SR	_	0.3	V	4)
	I_{M}	SR	-	15	mA	
Maximum current for all pins (excluding $V_{\rm DDP}$ and $V_{\rm SS}$)	$\Sigma I_{M} $	SR	_	60	mA	
$\begin{array}{c} \\ \text{Maximum current into} \\ V_{\text{DDP}} \end{array}$	I _{MVDE}	SR	_	80	mA	3)
Maximum current out of $V_{\rm SS}$	I _{MVSS}	SR	_	80	mA	3)



Table 33 Input/Output Characteristics (Operating Conditions apply)

Parameter	Symbol	Limit Values		Unit	Test Conditions
		min.	max.		
V_{DDP} = 3.3V Range					
Output low voltage	V_{OL} CC	-	1.0	V	I_{OL} = 8 mA
		_	0.4	V	$I_{\rm OL}$ = 2.5 mA
Output high voltage	V _{OH} CC	<i>V</i> _{DDP} - 1.0	_	V	I_{OH} = -8 mA
		V _{DDP} - 0.4	_	V	$I_{OH} = -2.5 \text{ mA}$
Input low voltage on port pins (all except P0.0 & P0.1)	V_{ILP} SR	_	$0.3 \times V_{DDP}$	V	CMOS Mode
Input low voltage on P0.0 & P0.1	V_{ILP0} SR	-0.2	$0.3 imes V_{DDP}$	V	CMOS Mode
Input low voltage on RESET pin	V_{ILR} SR	_	$0.3 imes V_{DDP}$	V	CMOS Mode
Input low voltage on TMS pin	V_{ILT} SR	_	$0.3 imes V_{DDP}$	V	CMOS Mode
Input high voltage on port pins (all except P0.0 & P0.1)	V _{IHP} SR	$0.7 \times V_{ m DDP}$	_	V	CMOS Mode
Input high voltage on P0.0 & P0.1	$V_{IHP0}SR$	$0.7 imes V_{DDP}$	V_{DDP}	V	CMOS Mode
Input high voltage on RESET pin	V_{IHR} SR	$0.7 imes V_{DDP}$	_	V	CMOS Mode
Input high voltage on TMS pin	V_{IHT} SR	$0.75 \times \\ V_{DDP}$	_	V	CMOS Mode
Input Hysteresis ¹⁾ on Port Pins	HYS CC	$0.03 \times \\ V_{DDP}$	_	V	CMOS Mode
Input Hysteresis ¹⁾ on XTAL1	HYSXCC	$V_{ m DDC}$	_	V	
Input low voltage at XTAL1	V_{ILX} SR	V _{SS} - 0.5	$0.3 imes V_{ m DDC}$	V	
Input high voltage at XTAL1	V_{IHX} SR	$0.7 imes V_{ m DDC}$	<i>V</i> _{DDC} + 0.5	V	



Table 33 Input/Output Characteristics (Operating Conditions apply)

Parameter	Symb	ool	Limit	Values	Unit	Test Conditions	
			min.	max.			
Pull-up current	I_{PU}	SR	_	-5	μΑ	$V_{IH,min}$	
			-50	_	μΑ	$V_{IL,max}$	
Pull-down current	I_{PD}	SR	_	5	μΑ	$V_{IL,max}$	
			50	_	μΑ	$V_{IH,min}$	
Input leakage current ²⁾	I_{OZ1}	CC	-2	2	μΑ	$0 < V_{\text{IN}} < V_{\text{DDP}},$ $T_{\text{A}} \le 150^{\circ}\text{C}$	
Input current at XTAL1	I_{ILX}	CC	- 10	10	μΑ		
Overload current on any pin	I_{OV}	SR	-5	5	mA	3)	
Absolute sum of overload currents	$\Sigma I_{OV} $	SR	_	25	mA	3)	
Voltage on any pin during V_{DDP} power off	V_{PO}	SR	_	0.3	V	4)	
	I_{M}	SR	_	15	mA		
$\begin{array}{c} \text{Maximum current for all} \\ \text{pins (excluding } V_{\text{DDP}} \\ \text{and } V_{\text{SS}}) \end{array}$	$\Sigma I_{M} $	SR	_	60	mA		
$\begin{tabular}{ll} \hline & & \\ $	I _{MVDE}	P SR	_	80	mA		
$\overline{\text{Maximum current out of}} \\ V_{\text{SS}}$	I _{MVSS}	SR	_	80	mA		

Not subjected to production test, verified by design/characterization. Hysteresis is implemented to avoid meta stable states and switching due to internal ground bounce. It cannot be guaranteed that it suppresses switching due to external system noise.

²⁾ An additional error current (I_{INJ}) will flow if an overload current flows through an adjacent pin. TMS pin and RESET pin have internal pull devices and are not included in the input leakage current characteristic.

³⁾ Not subjected to production test, verified by design/characterization.

⁴⁾ Not subjected to production test, verified by design/characterization. However, for applications with strict low power-down current requirements, it is mandatory that no active voltage source is supplied at any GPIO pin when VDDP is powered off.



4.2.2 Supply Threshold Characteristics

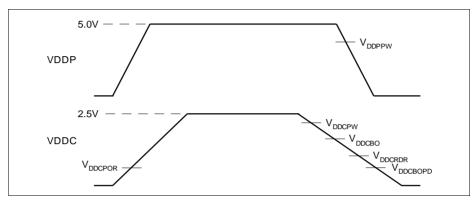


Figure 35 Supply Threshold Parameters

Table 34 Supply Threshold Parameters (Operating Conditions apply)

Parameters	Symbol		I	Unit		
			min.	typ.	max.	
V _{DDC} prewarning voltage ¹⁾	$V_{\rm DDCPW}$	СС	2.2	2.3	2.4	V
$V_{\rm DDC}$ brownout voltage in active mode ¹⁾	$V_{\rm DDCBO}$	СС	2.0	2.1	2.2	V
RAM data retention voltage	$V_{\rm DDCRDR}$	СС	0.9	1.0	1.1	V
$V_{\rm DDC}$ brownout voltage in power-down mode ²⁾	$V_{\rm DDCBOPD}$	СС	1.3	1.5	1.7	V
V _{DDP} prewarning voltage ³⁾	$V_{\rm DDPPW}$	CC	3.3	4.0	4.65	V
Power-on reset voltage ²⁾⁴⁾	$V_{\rm DDCPOR}$	СС	1.3	1.5	1.7	V

¹⁾ Detection is disabled in power-down mode.

²⁾ Detection is enabled in both active and power-down mode.

³⁾ Detection is enabled for external power supply of 5.0V Detection must be disabled for external power supply of 3.3V.

 $^{^{4)}}$ The reset of EVR is extended by 300 μs typically after the VDDC reaches the power-on reset voltage.



4.2.3 ADC Characteristics

The values in the table below are given for an analog power supply between 4.5 V to 5.5 V. The ADC can be used with an analog power supply down to 3 V. But in this case, the analog parameters may show a reduced performance. All ground pins ($V_{\rm SS}$) must be externally connected to one single star point in the system. The voltage difference between the ground pins must not exceed 200mV.

Table 35 ADC Characteristics (Operating Conditions apply; $V_{\text{DDP}} = 5V$ Range)

Parameter	Symbol	Li	mit Valu	es	Unit	Test Conditions/
		min.	typ.	max.		Remarks
Analog reference voltage	V _{AREF} SR	V _{AGND} + 1	V_{DDP}	V _{DDP} + 0.05	V	1)
Analog reference ground	V_{AGND} SR	V _{SS} - 0.05	V _{SS}	V _{AREF}	V	1)
Analog input voltage range	V _{AIN} SR	V_{AGND}	_	V_{AREF}	V	
ADC clocks	f_{ADC}	_	20	40	MHz	module clock ¹⁾
	f _{ADCI}	_	_	10	MHz	internal analog clock ¹⁾ See Figure 32
Sample time	t _S CC	(2 + INF t _{ADCI}	PCR0.S	TC) ×	μs	1)
Conversion time	t _C CC	See Se	ction 4.	2.3.1	μs	1)
Total unadjusted	TUE CC	_	_	1	LSB	8-bit conversion. ²⁾
error		_	_	2	LSB	10-bit conversion. ²⁾
Differential Nonlinearity	<i>EA</i> _{DNL} CC	-	1	-	LSB	10-bit conversion ¹⁾
Integral Nonlinearity	<i>EA</i> _{INL} CC	-	1	-	LSB	10-bit conversion ¹⁾
Offset	EA _{OFF} CC	-	1	-	LSB	10-bit conversion ¹⁾
Gain	<i>EA_{GAIN}</i> CC	-	1	-	LSB	10-bit conversion ¹⁾
Overload current coupling factor for	K _{OVA} CC	-	_	1.0 x 10 ⁻⁴	_	$I_{\rm OV} > 0^{1)3)$
analog inputs		-	_	1.5 x 10 ⁻³	_	$I_{\rm OV} < 0^{1)3)$



Table 35 ADC Characteristics (Operating Conditions apply; V_{DDP} = 5V Range)

	1		•			
Parameter	Symbol	L	imit Valu	ies	Unit	Test Conditions/
		min.	typ.	max.		Remarks
Overload current coupling factor for	K _{OVD} CC	_	-	5.0 x 10 ⁻³	_	$I_{\rm OV} > 0^{1)3)$
digital I/O pins		-	-	1.0 x 10 ⁻²	_	$I_{\text{OV}} < 0^{1)3)$
Switched capacitance at the reference voltage input	C _{AREFSW} CC	-	10	20	pF	1)4)
Switched capacitance at the analog voltage inputs	C _{AINSW} CC	-	5	7	pF	1)5)
Input resistance of the reference input	R _{AREF} CC	-	1	2	kΩ	1)
Input resistance of the selected analog channel	R _{AIN} CC	-	1	1.5	kΩ	1)

¹⁾ Not subject to production test, verified by design/characterization.

TUE is tested at $V_{AREF} = 5.0 \text{ V}$, $V_{AGND} = 0 \text{ V}$, $V_{DDP} = 5.0 \text{ V}$.

An overload current (I_{OV}) through a pin injects a certain error current (I_{INJ}) into the adjacent pins. This error current adds to the respective pin's leakage current (I_{OZ}) . The amount of error current depends on the overload current and is defined by the overload coupling factor K_{OV} . The polarity of the injected error current is inverse compared to the polarity of the overload current that produces it. The total current through a pin is $|I_{TOT}| = |I_{OZ1}| + (|I_{OV}| \times K_{OV})$. The additional error current may distort the input voltage on analog inputs.

⁴⁾ This represents an equivalent switched capacitance. This capacitance is not switched to the reference voltage at once. Instead of this, smaller capacitances are successively switched to the reference voltage.

⁵⁾ The sampling capacity of the conversion C-Network is pre-charged to V_{AREF}/2 before connecting the input to the C-Network. Because of the parasitic elements, the voltage measured at ANx is lower than V_{AREF}/2.



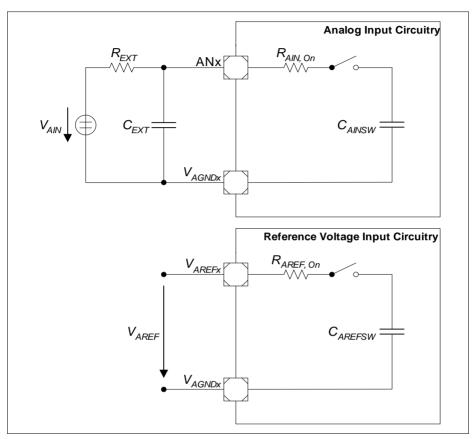


Figure 36 ADC Input Circuits

4.2.3.1 ADC Conversion Timing

```
Conversion time, t_C = t_{ADC} \times (1 + r \times (3 + n + STC)), where r = CTC + 2 for CTC = 00_B, 01_B or 10_B, r = 32 for CTC = 11_B, CTC = Conversion Time Control (GLOBCTR.CTC), STC = Sample Time Control (INPCR0.STC), n = 8 or 10 (for 8-bit and 10-bit conversion respectively), t_{ADC} = 1/f_{ADC}
```



4.2.4 Power Supply Current

Table 36 Power Supply Current Parameters (Operating Conditions apply)

Parameter	Symbol	Limit '	Values	Unit	Test Condition
		typ. ¹⁾	max. ²⁾		
Active Mode	I_{DDP}	22.6	25.1	mA	3)
Idle Mode	I_{DDP}	17.2	19.7	mA	4)
Active Mode with slow-down enabled	I_{DDP}	7.2	9.3	mA	5)
Idle Mode with slow-down enabled	I_{DDP}	7.1	8	mA	6)

¹⁾ The typical $I_{\rm DDP}$ values are periodically measured at $T_{\rm A}$ = + 25 °C and $V_{\rm DDP}$ = 5.0 V.

²⁾ The maximum I_{DDP} values are measured under worst case conditions (T_A = + 150 °C and V_{DDP} = 5.5 V).

³⁾ I_{DDP} (active mode) is measured with: CPU clock and input clock to all peripherals running at 25 MHz(set by on-chip oscillator of 10 MHz and NDIV in PLL_CON to 0001_B), RESET = V_{DDP}.

⁴⁾ I_{DDP} (idle mode) is measured with: CPU clock disabled, watchdog timer disabled, input clock to all peripherals enabled and running at 25 MHz, RESET = V_{DDP}.

⁵⁾ I_{DDP} (active mode with slow-down mode) is measured with: CPU clock and input clock to all peripherals running at 781 KHz by setting CLKREL in CMCON to 0101_B, RESET = V_{DDP}.

⁶⁾ I_{DDP} (idle mode with slow-down mode) is measured with: CPU clock disabled, watchdog timer disabled, input clock to all peripherals enabled and running at 781 MHz by setting CLKREL in CMCON to 0101_B, RESET = V_{DDP}.



Table 37 Power Down Current (Operating Conditions apply)

Parameter	Symbol	Limit Values		Limit Values		Unit	Test Condition
		typ. ¹⁾	max. ²⁾				
Power-Down Mode ³⁾	I_{PDP}	1	10	μΑ	$T_{A} = + 25 {}^{\circ}\text{C.}^{4)}$		
		-	30	μΑ	$T_{A} = +85 {}^{\circ}\text{C.}^{4)5)}$		

 $^{^{1)}~}$ The typical $I_{\rm PDP}$ values are measured at $V_{\rm DDP}$ = 5.0 V.

Data Sheet 98 V1.1, 2012-12

²⁾ The maximum $I_{\rm PDP}$ values are measured at $V_{\rm DDP}$ = 5.5 V.

 $^{^{3)}}$ I_{PDP} (power-down mode) has a maximum value of 500 μ A at T_A = + 150 °C.

⁴⁾ I_{PDP} (power-down mode) is measured with: RESET = V_{DDP}, V_{AGND}= V_{SS}, RXD/INT0 = V_{DDP}; rest of the ports are programmed to be input with either internal pull devices enabled or driven externally to ensure no floating inputs.

⁵⁾ Not subject to production test, verified by design/characterization.



4.3 AC Parameters

4.3.1 Testing Waveforms

The testing waveforms for rise/fall time, output delay and output high impedance are shown in Figure 37, Figure 38 and Figure 39.

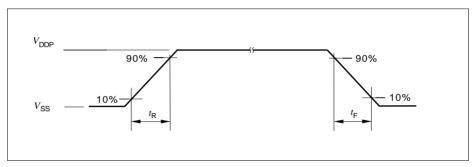


Figure 37 Rise/Fall Time Parameters

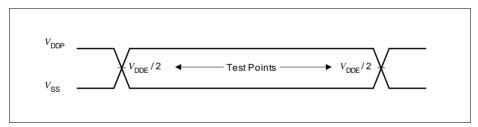


Figure 38 Testing Waveform, Output Delay

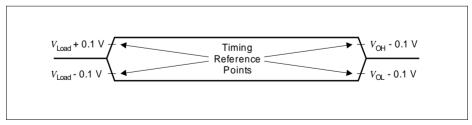


Figure 39 Testing Waveform, Output High Impedance



4.3.2 Output Rise/Fall Times

Table 38 Output Rise/Fall Times Parameters (Operating Conditions apply)

Parameter	Symbol	_	Limit Values		Test Conditions	
		min.	max.			
V_{DDP} = 5V Range		<u>'</u>		<u>'</u>	1	
Rise/fall times 1) 2)	t _R , t _F	-	10	ns	20 pF. ³⁾	
$V_{\rm DDP}$ = 3.3V Range		•				
Rise/fall times 1) 2)	t _R , t _F	_	10	ns	20 pF. ⁴⁾	

¹⁾ Rise/Fall time measurements are taken with 10% - 90% of the pad supply.

 $^{^{4)}}$ Additional rise/fall time valid for C_L = 20pF - 100pF @ 0.225 ns/pF.

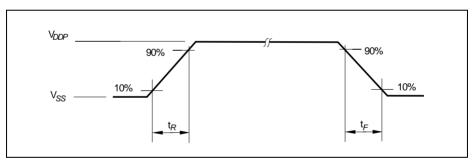


Figure 40 Rise/Fall Times Parameters

²⁾ Not all parameters are 100% tested, but are verified by design/characterization and test correlation.

 $^{^{3)}}$ Additional rise/fall time valid for C_L = 20pF - 100pF @ 0.125 ns/pF.



4.3.3 Power-on Reset and PLL Timing

Table 39 Power-On Reset and PLL Timing (Operating Conditions apply)

Parameter	Symbol	Limit Values			Unit	Test Conditions
		min.	typ.	max.		
Pad operating voltage	V_{PAD} CC	2.3	-	_	V	1)
On-Chip Oscillator start-up time	t _{OSCST} CC	_	-	500	ns	1)
Flash initialization time	t _{FINIT} CC	_	160	_	μs	1)
RESET hold time	t _{RST} SR	_	500	_	μs	$V_{\rm DDP}$ rise time $(10\% - 90\%) \le 500 \mu s^{1)2)}$
PLL lock-in in time	$t_{LOCK}CC$	-	_	200	μs	1)
PLL accumulated jitter	D _P	-	_	0.7	ns	1)

¹⁾ Not all parameters are 100% tested, but are verified by design/characterization and test correlation.

 $^{^{2)}}$ RESET signal has to be active (low) until $V_{
m DDC}$ has reached 90% of its maximum value (typ. 2.5V).

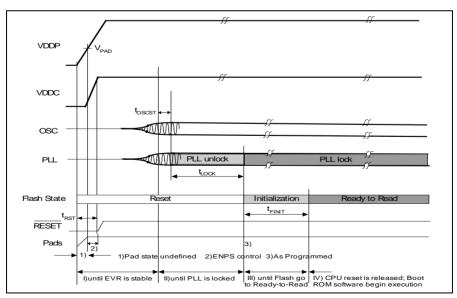


Figure 41 Power-on Reset Timing



4.3.4 On-Chip Oscillator Characteristics

Table 40 On-chip Oscillator Characteristics (Operating Conditions apply)

Parameter	Symbol	Lir	nit Va	lues	Unit	Test Conditions
		min.	typ.	max.	Ī	
Nominal frequency	f _{NOM} CC	9.75	10	10.25	MHz	under nominal conditions ¹⁾
Long term frequency deviation	Δf_{LT} CC	0	_	6.0	%	with respect to f_{NOM} , over lifetime and temperature (125°C to 150°C), for one device after trimming
		-5.0	_	5.0	%	with respect to f_{NOM} , over lifetime and temperature (-10°C to 125°C), for one device after trimming
		-6.0	_	0	%	with respect to f_{NOM} , over lifetime and temperature (-40°C to -10°C), for one device after trimming
Short term frequency deviation	Δf_{ST} CC	-1.0	_	1.0	%	within one LIN message (<10 ms 100 ms)

¹⁾ Nominal condition: $V_{DDC} = 2.5 \text{ V}$, $T_A = +25 ^{\circ}\text{C}$.



4.3.5 JTAG Timing

Table 41 TCK Clock Timing (Operating Conditions apply; $C_L = 50 \text{ pF}$)

Parameter	Symbol	Lir	Unit	
		min	max	
TCK clock period ¹⁾	t _{TCK} SR	50	-	ns
TCK high time ¹⁾	t_1 SR	20	_	ns
TCK low time ¹⁾	t_2 SR	20	_	ns
TCK clock rise time ¹⁾	t ₃ SR	_	4	ns
TCK clock fall time ¹⁾	t ₄ SR	_	4	ns

¹⁾ Not all parameters are 100% tested, but are verified by design/characterization and test correlation.

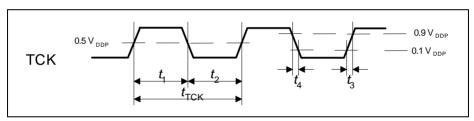


Figure 42 TCK Clock Timing



Table 42 JTAG Timing (Operating Conditions apply; $C_L = 50 \text{ pF}$)

Parameter	Syı	nbol	Lir	Unit	
			min	max	
TMS setup to TCK ¹⁾ _r	t_1	SR	8.0	-	ns
TMS hold to TCK ¹⁾ _r	t_2	SR	5.0	_	ns
TDI setup to TCK ¹⁾ _r	t_1	SR	11.0	_	ns
TDI hold to TCK ¹⁾ _r	t_2	SR	6.0	_	ns
TDO valid output from TCK ¹⁾ ~	t_3	CC	-	23	ns
TDO high impedance to valid output from TCK1) ¬	t_4	CC	_	26	ns
TDO valid output to high impedance from TCK ¹⁾ ¬	<i>t</i> ₅	CC	-	18	ns

¹⁾ Not all parameters are 100% tested, but are verified by design/characterization and test correlation.

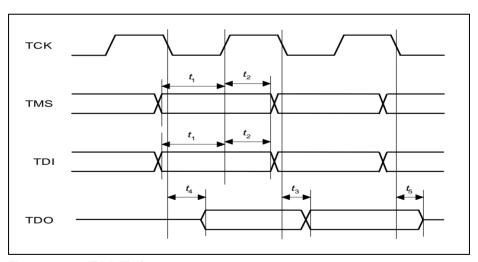


Figure 43 JTAG Timing



4.3.6 SSC Master Mode Timing

Table 43 SSC Master Mode Timing (Operating Conditions apply; $C_L = 50 \text{ pF}$)

Parameter	Symbol	Limit	Unit	
		min.	max.	
SCLK clock period ¹⁾	t ₀ CC	2*T _{SSC} ²⁾	_	ns
MTSR delay from SCLK ¹⁾ _	t ₁ CC	0	8	ns
MRST setup to SCLK ¹⁾ ¬	t ₂ SR	22	_	ns
MRST hold from SCLK ¹⁾ ¬_	t ₃ SR	0	_	ns

¹⁾ Not all parameters are 100% tested, but are verified by design/characterization and test correlation.

²⁾ $T_{SSCmin} = T_{CPU} = 1/f_{CPU}$. When $f_{CPU} = 25$ MHz, $t_0 = 80$ ns. T_{CPU} is the CPU clock period.

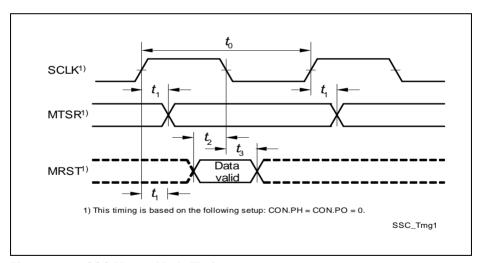


Figure 44 SSC Master Mode Timing



Package and Reliability

5 Package and Reliability

5.1 Package Parameters (PG-TSSOP-38)

Table 44 provides the thermal characteristics of the package.

Table 44 Thermal Characteristics of the Package

Parameter	Symbol		Limit	t Values	Unit	Notes
			Min.	Max.		
Thermal resistance junction case ¹⁾²⁾	R_{TJC}	СС	_	15.7	K/W	_
Thermal resistance junction lead ¹⁾²⁾	R_{TJL}	CC	_	39.2	K/W	_

The thermal resistances between the case and the ambient (R_{TCA}), the lead and the ambient (R_{TLA}) are to be combined with the thermal resistances between the junction and the case (R_{TJC}), the junction and the lead (R_{TJL}) given above, in order to calculate the total thermal resistance between the junction and the ambient (R_{TJA}). The thermal resistances between the case and the ambient (R_{TCA}), the lead and the ambient (R_{TLA}) depend on the external system (PCB, case) characteristics, and are under user responsibility.

Data Sheet 106 V1.1, 2012-12

The junction temperature can be calculated using the following equation: $T_J = T_A + R_{TJA} \times P_D$, where the R_{TJA} is the total thermal resistance between the junction and the ambient. This total junction ambient resistance R_{TJA} can be obtained from the upper four partial thermal resistances, by

a) simply adding only the two thermal resistances (junction lead and lead ambient), or

b) by taking all four resistances into account, depending on the precision needed.

²⁾ Not all parameters are 100% tested, but are verified by design/characterization and test correlation.



Package and Reliability

5.2 Package Outline

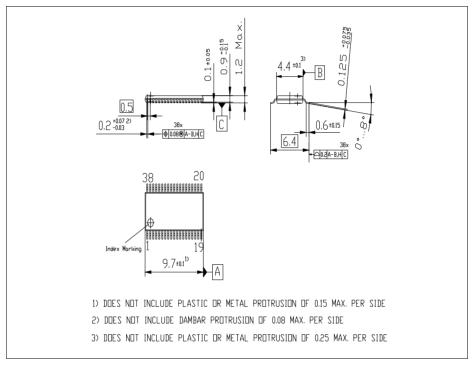


Figure 45 PG-TSSOP-38-4 Package Outline



Package and Reliability

5.3 Quality Declaration

Table 45 shows the characteristics of the quality parameters in the SAL-XC866.

Table 45 Quality Parameters

Parameter	Symbol	Limit Values			Unit	Notes	
		Min.	Тур.	Max.			
Operation Lifetime when the device is used at the four stated $T_A^{(1)2)}$	t _{OP}	_	_	500	hours	T _A = 150°C	
		_	_	1000	hours	T _A = 140°C	
		_	_	2000	hours	T _A = 125°C	
		_	_	10000	hours	<i>T</i> _A = 85°C	
		_	_	1500	hours	T _A = -40°C	
Operation Lifetime when the device is used at the two stated $T_A^{1)2)}$	t _{OP2}	_	_	18000	hours	T _A = 108°C	
		_	-	130000	hours	<i>T</i> _A = 27°C	
Weighted Average Temperature ²⁾³⁾	T_{WA}	_	107	_	°C	for 15000 hours	
ESD susceptibility according to Human Body Model (HBM) for all pins (except V _{DDC}) ²⁾	V_{HBM}	_	_	2000	V	Conforming to EIA/JESD22- A114-B	
ESD susceptibility according to Human Body Model (HBM) for $V_{\rm DDC}^{(2)}$	V_{HBMC}	_	_	600	V	Conforming to EIA/JESD22- A114-B	
ESD susceptibility according to Charged Device Model (CDM) pins ²⁾	V _{CDM}	_	_	750	V	Conforming to JESD22-C101-C	

¹⁾ This lifetime refers only to the time when the device is powered-on.

²⁾ Not all parameters are 100% tested, but are verified by design/characterization and test correlation.

³⁾ This parameter is derived based on the Arrhenius model.

www.infineon.com

Published by Infineon Technologies AG